

Understanding the dangers of blue light: thermal and photochemical damage models

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Overview

- The General Problem
- Motivation
- Laser light and the retina
- Damage models: predicting the threshold for damage
- A new model
- Conclusions

The General Problem

- Based on the exposure parameters at the cornea, will the retina be injured?
- What is the threshold for causing injury?

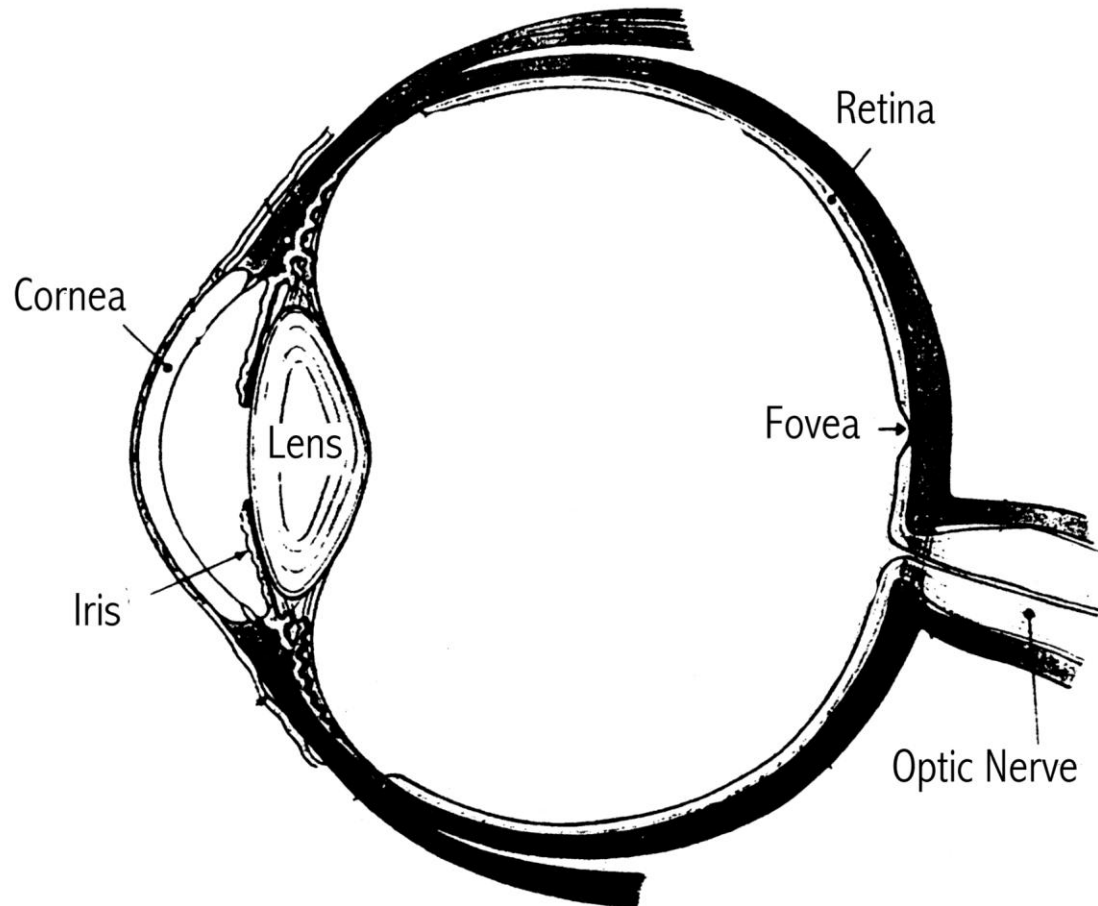


Motivation

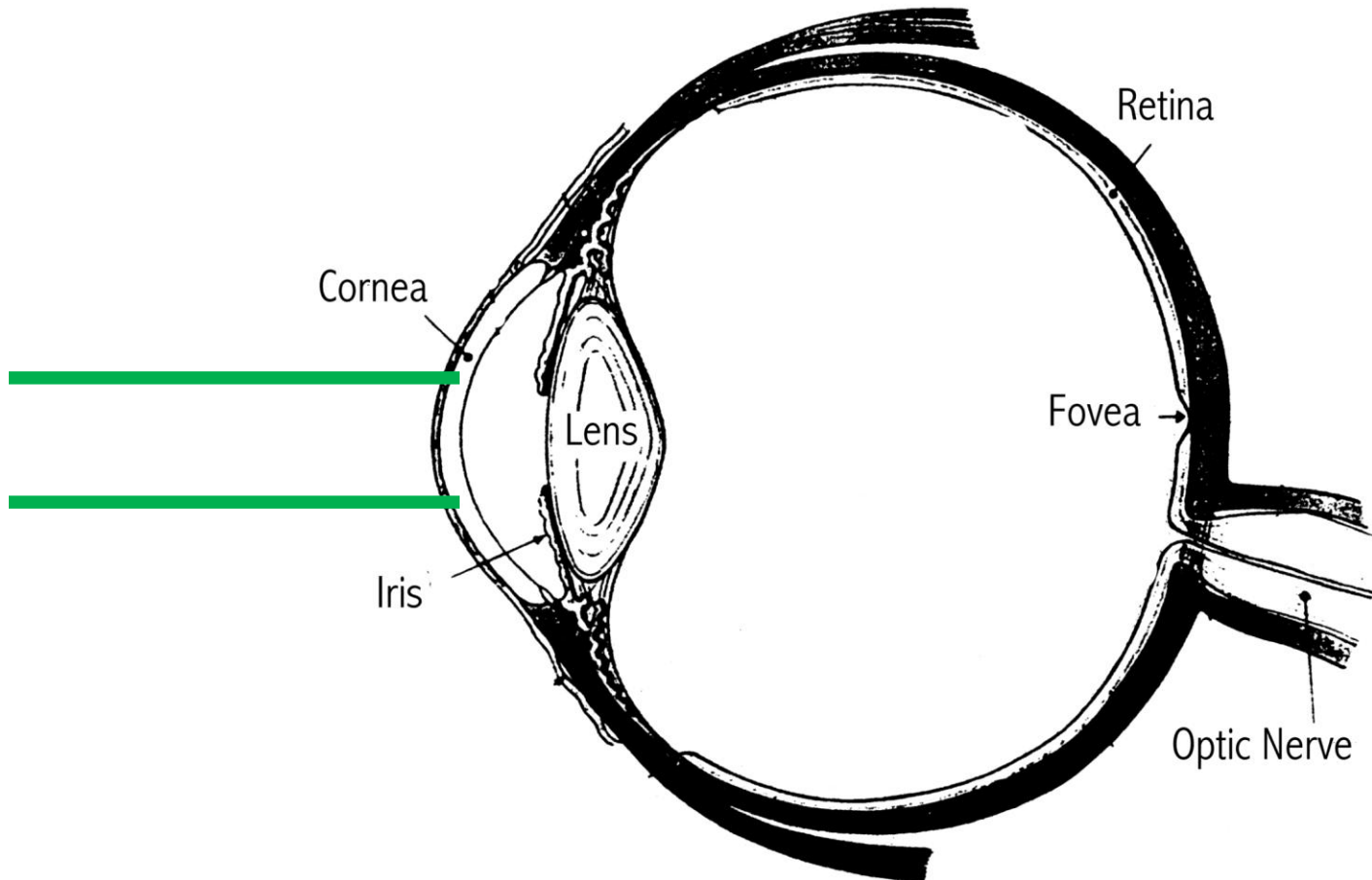
- Demonstrate an understanding of the underlying processes
- Supplement experiment
- Safety
 - Standards (ANSI Z136.1)
 - Laser classifications
 - Hazard zones
 - Protection
 - If we understand the process, we may be able to prevent it
- Medical
 - Surgery: controlled damage
 - Therapy: sub-threshold stimulation



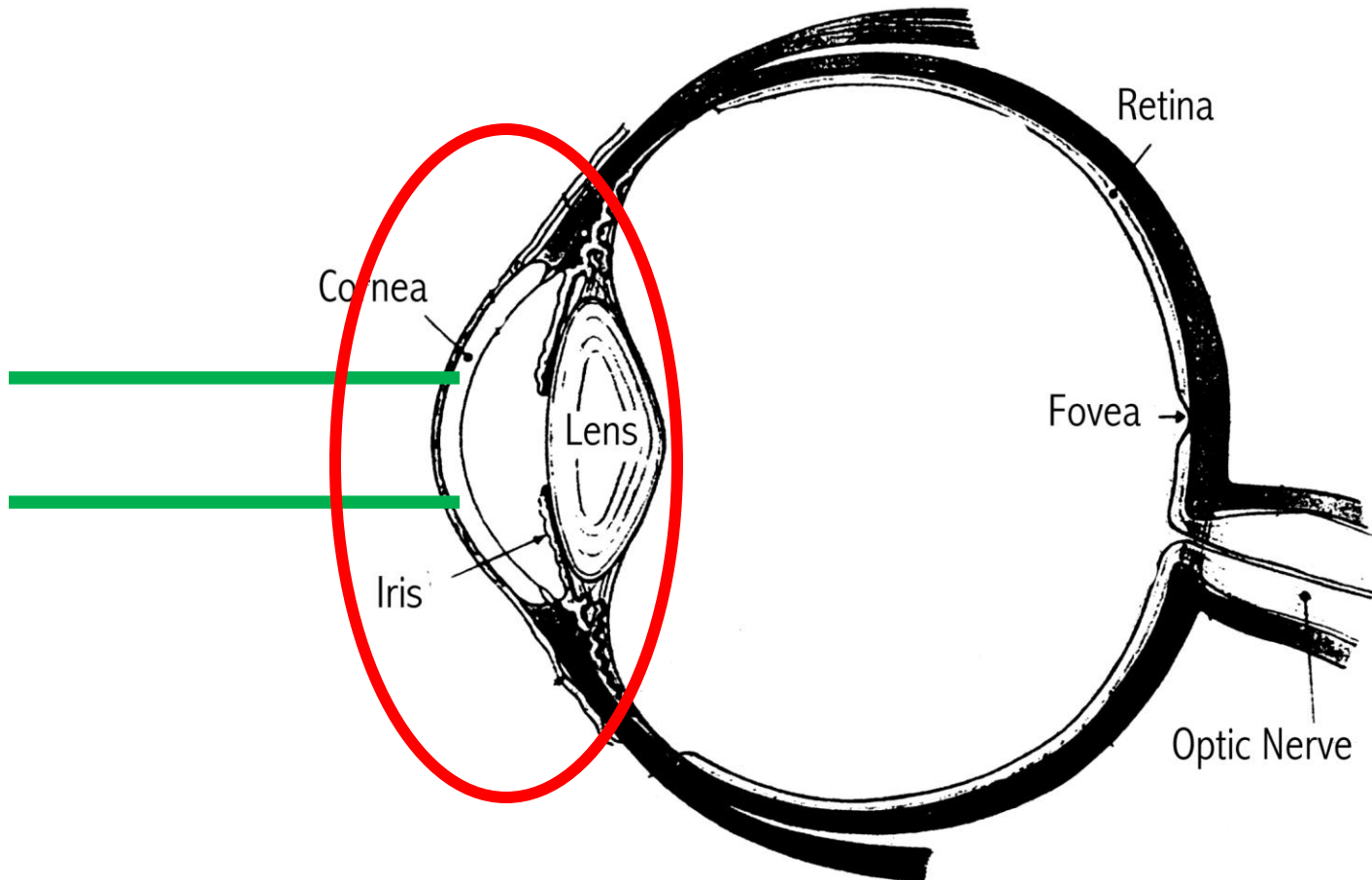
Laser light and the retina



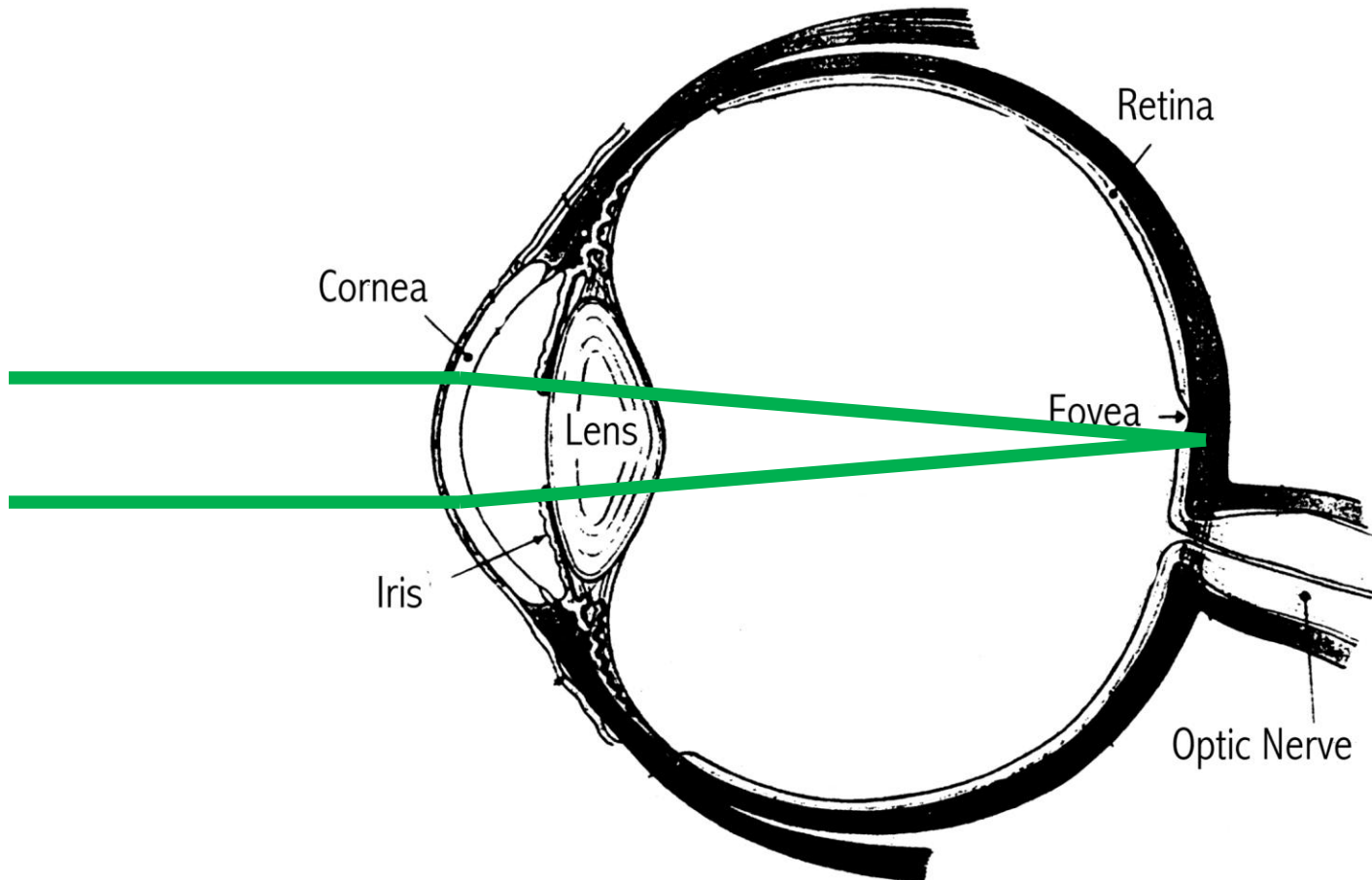
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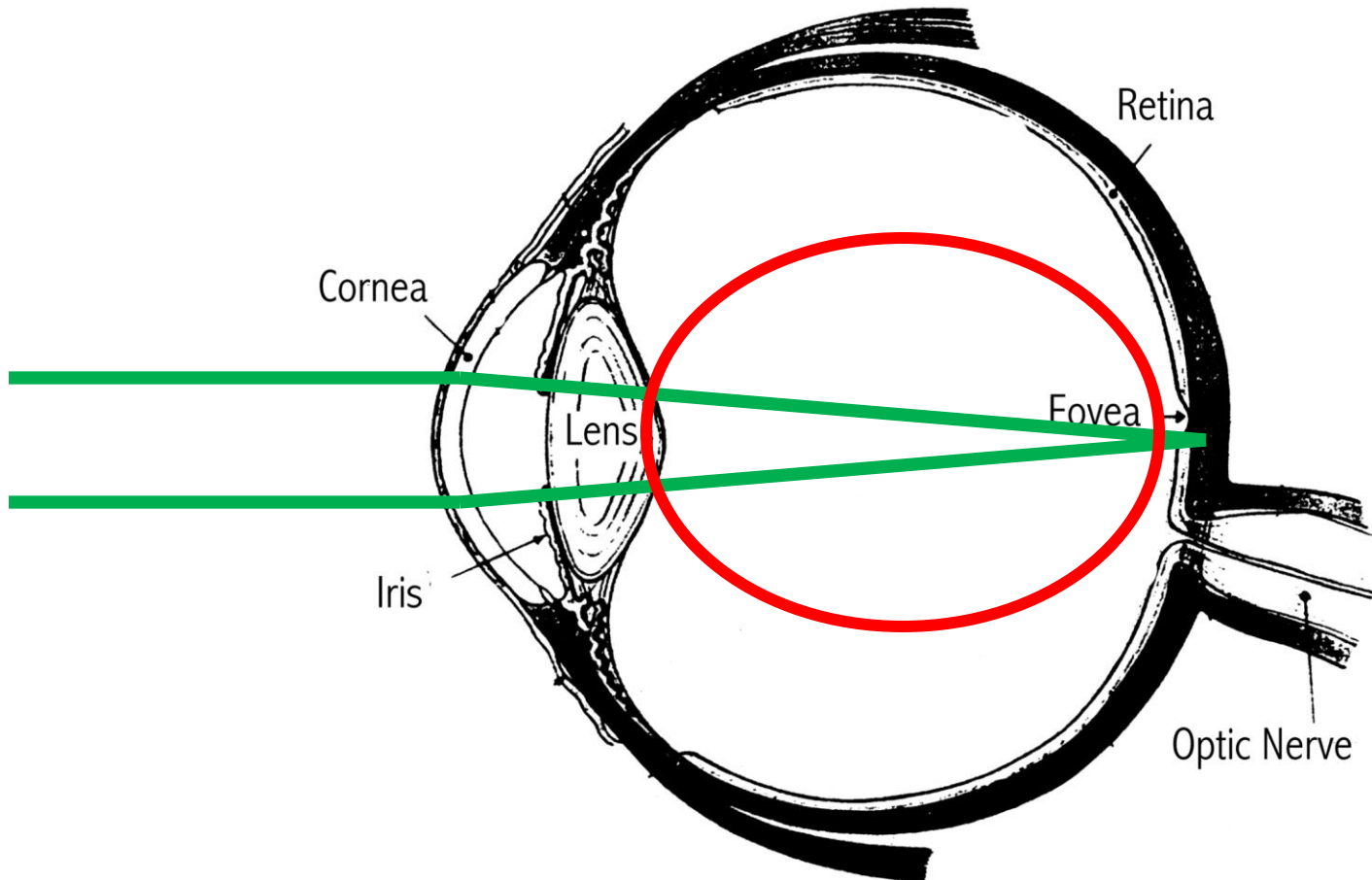
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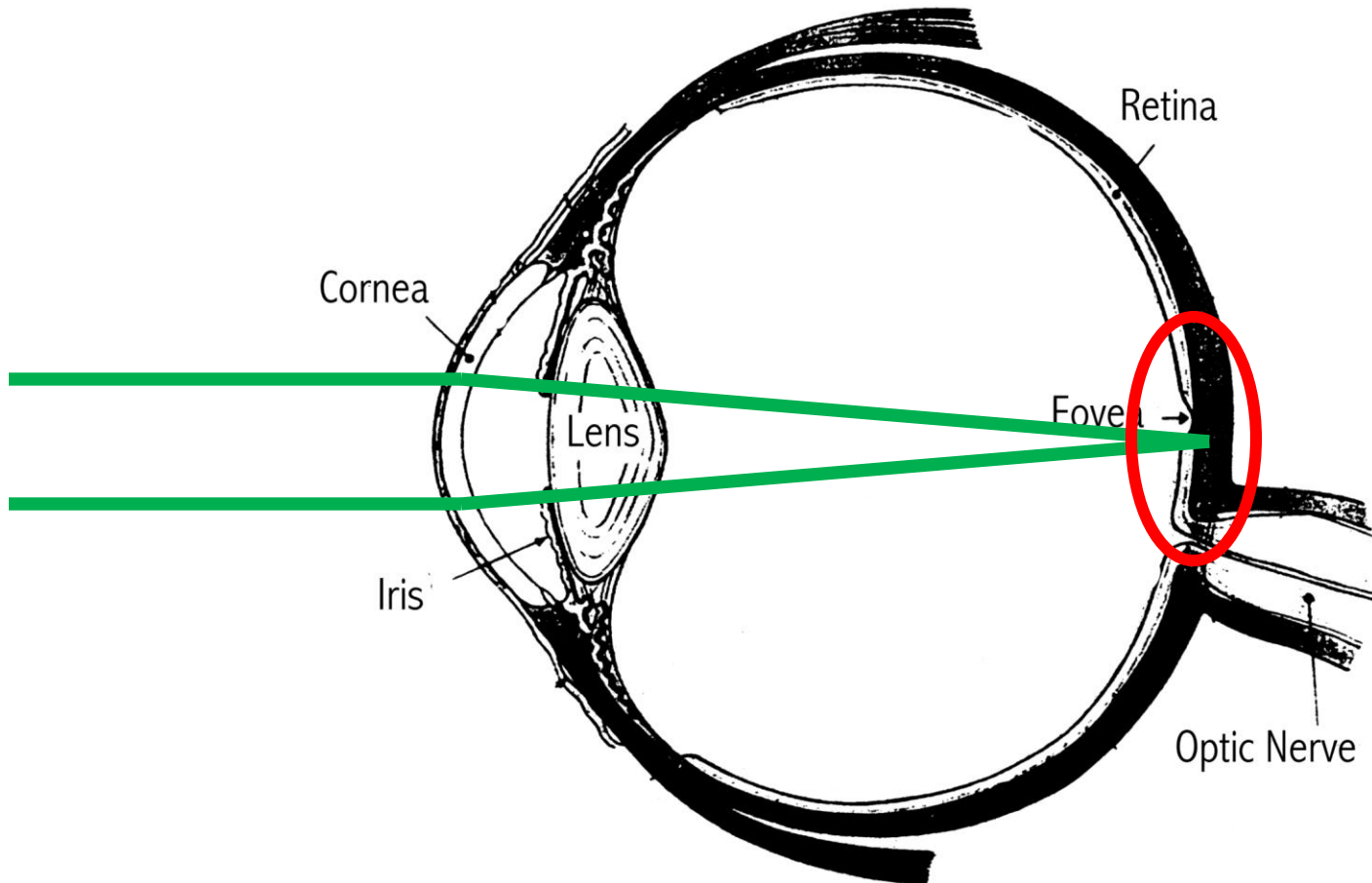
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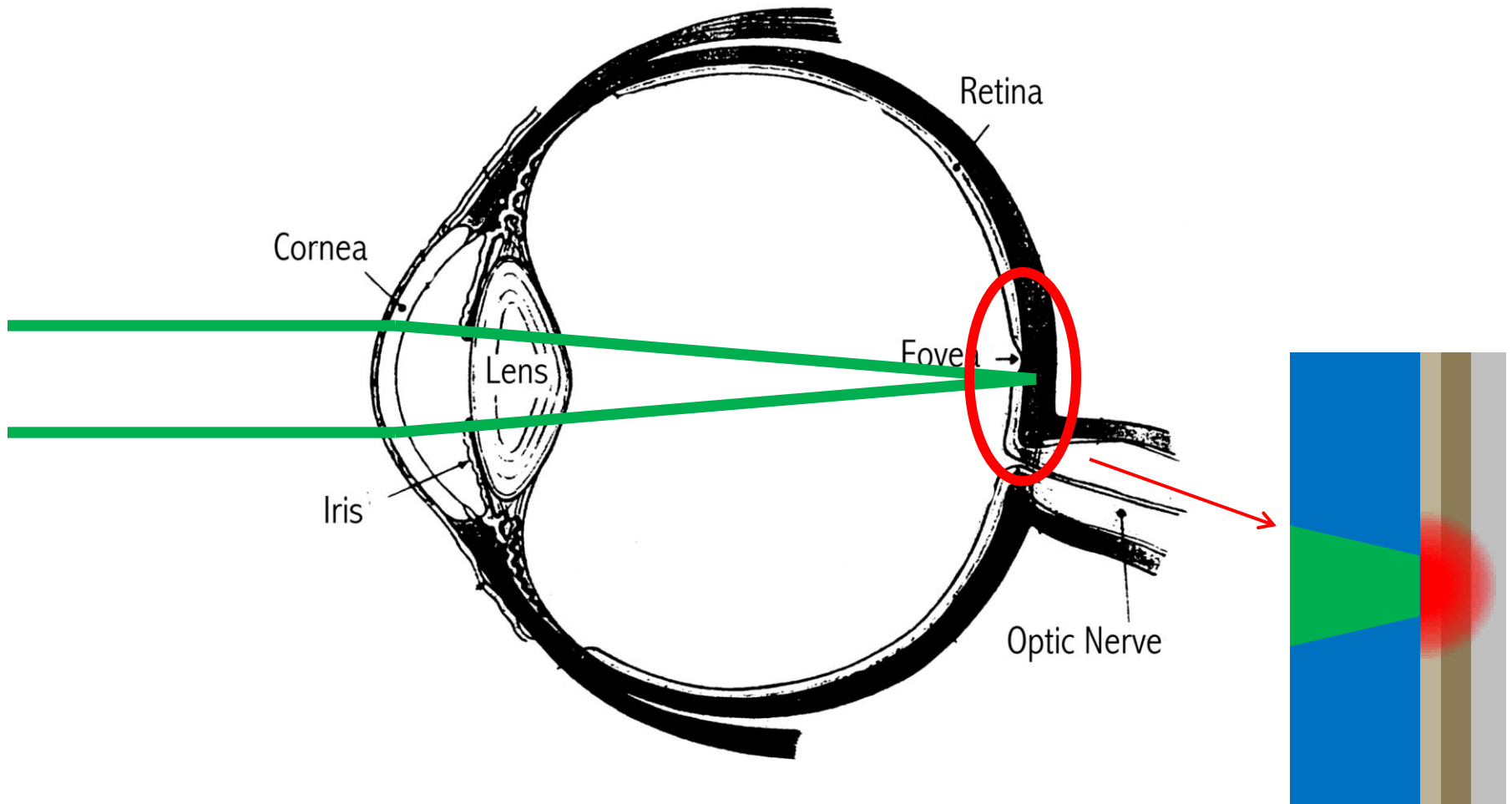
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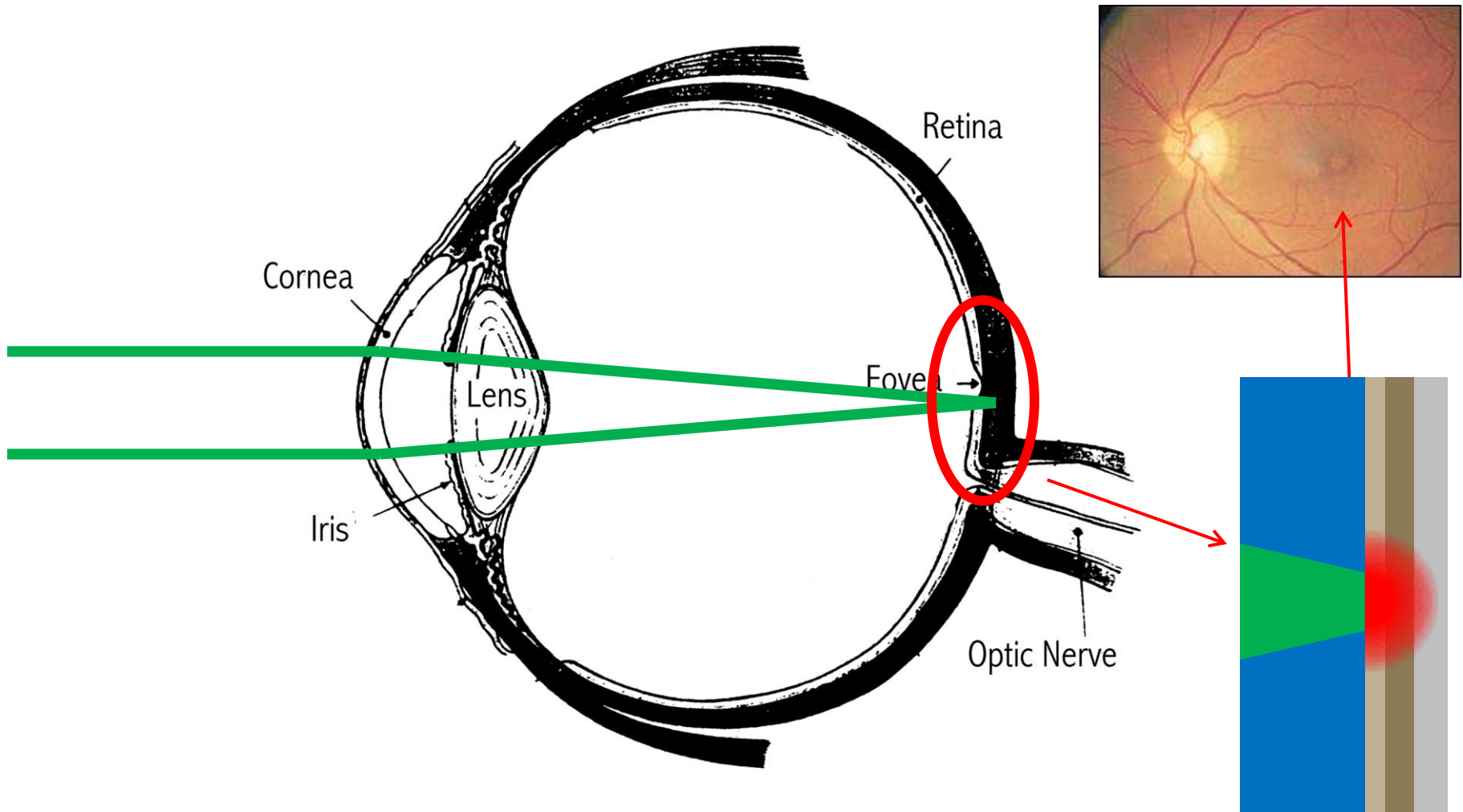
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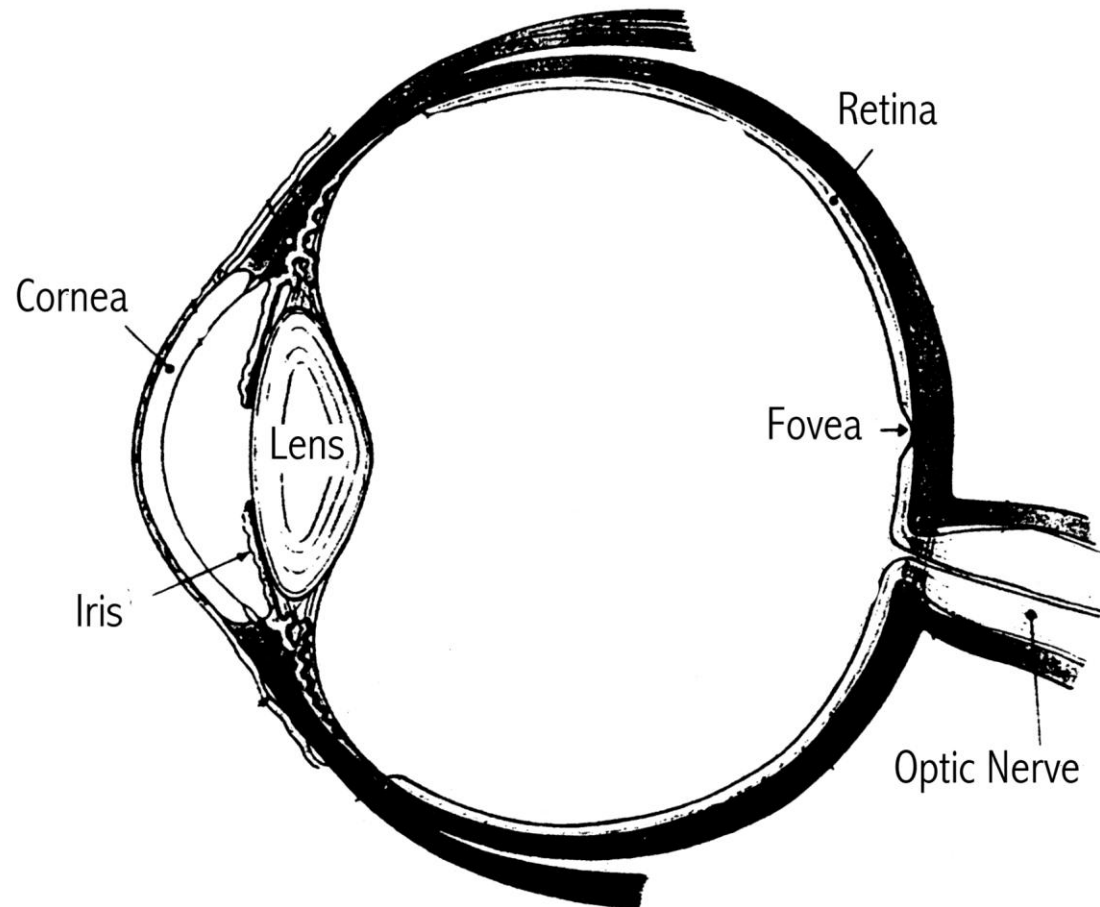
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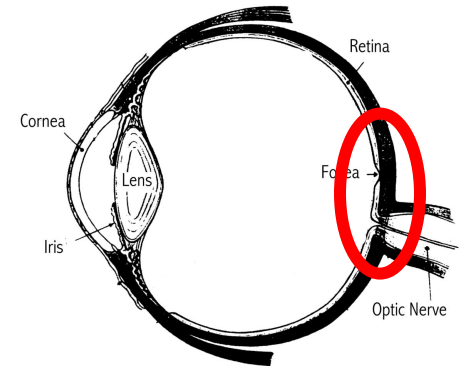


My Work

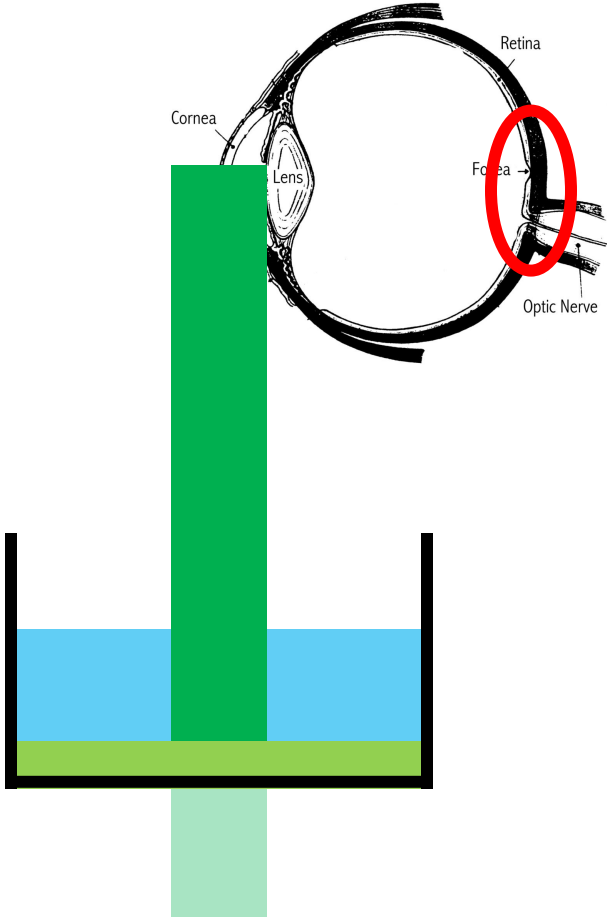


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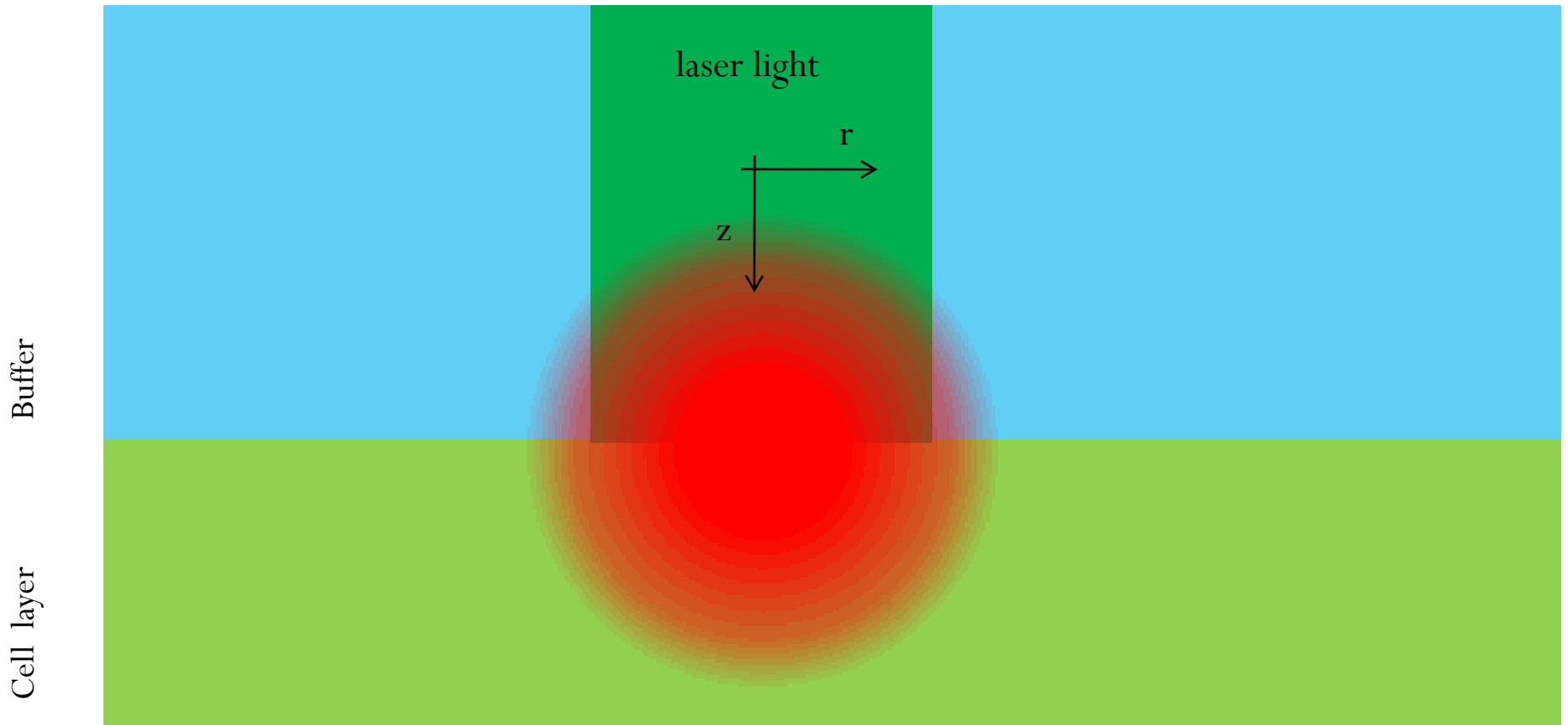
- Propagation
 - Thermal lensing
 - Ultrashort pulses
- Multiple pulse damage thresholds
- Rate Process Models
 - Photochemical damage



Cell Culture

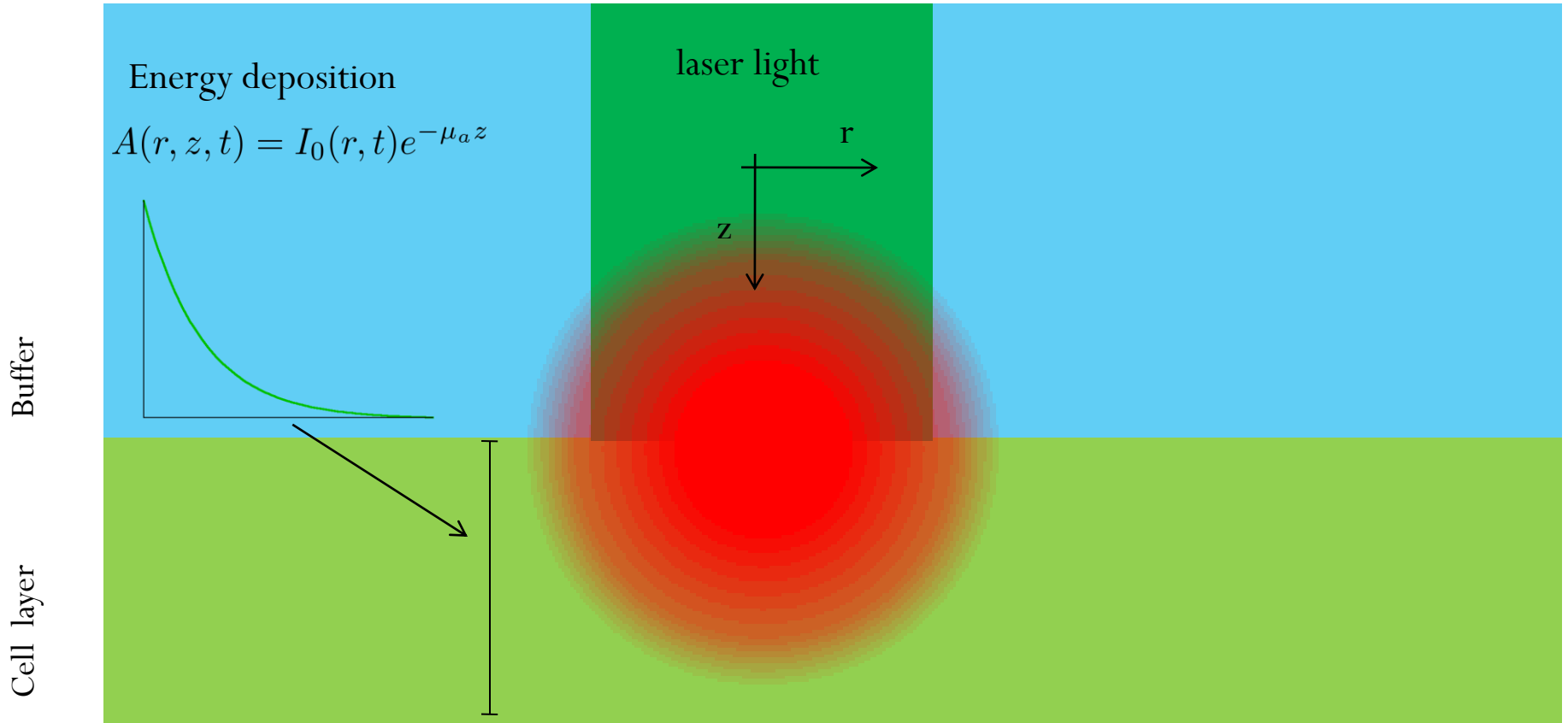


Cell Culture: Predicting Temperature



$$\rho c \frac{\partial T(r, z, t)}{\partial t} - \nabla \cdot \kappa \nabla T(r, z, t) = A(r, z, t)$$

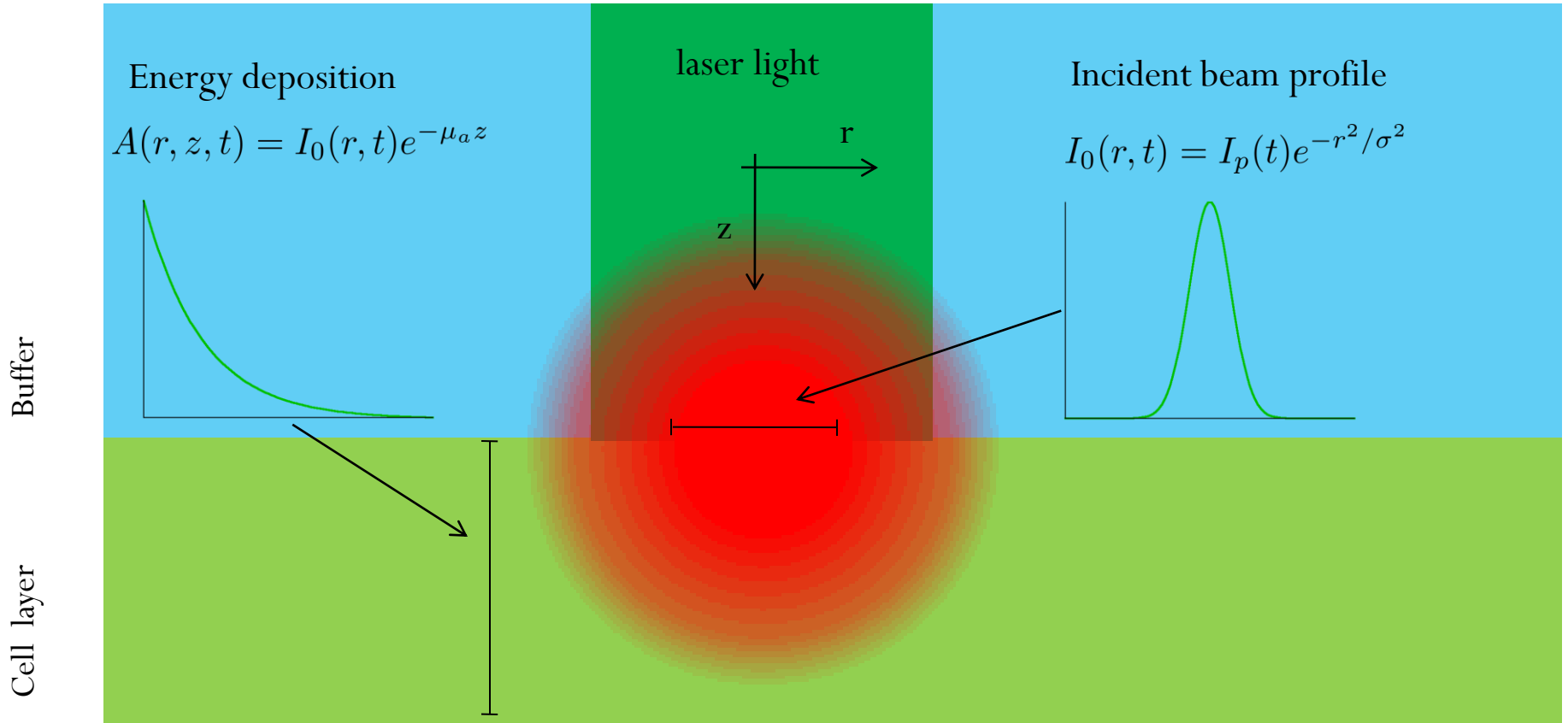
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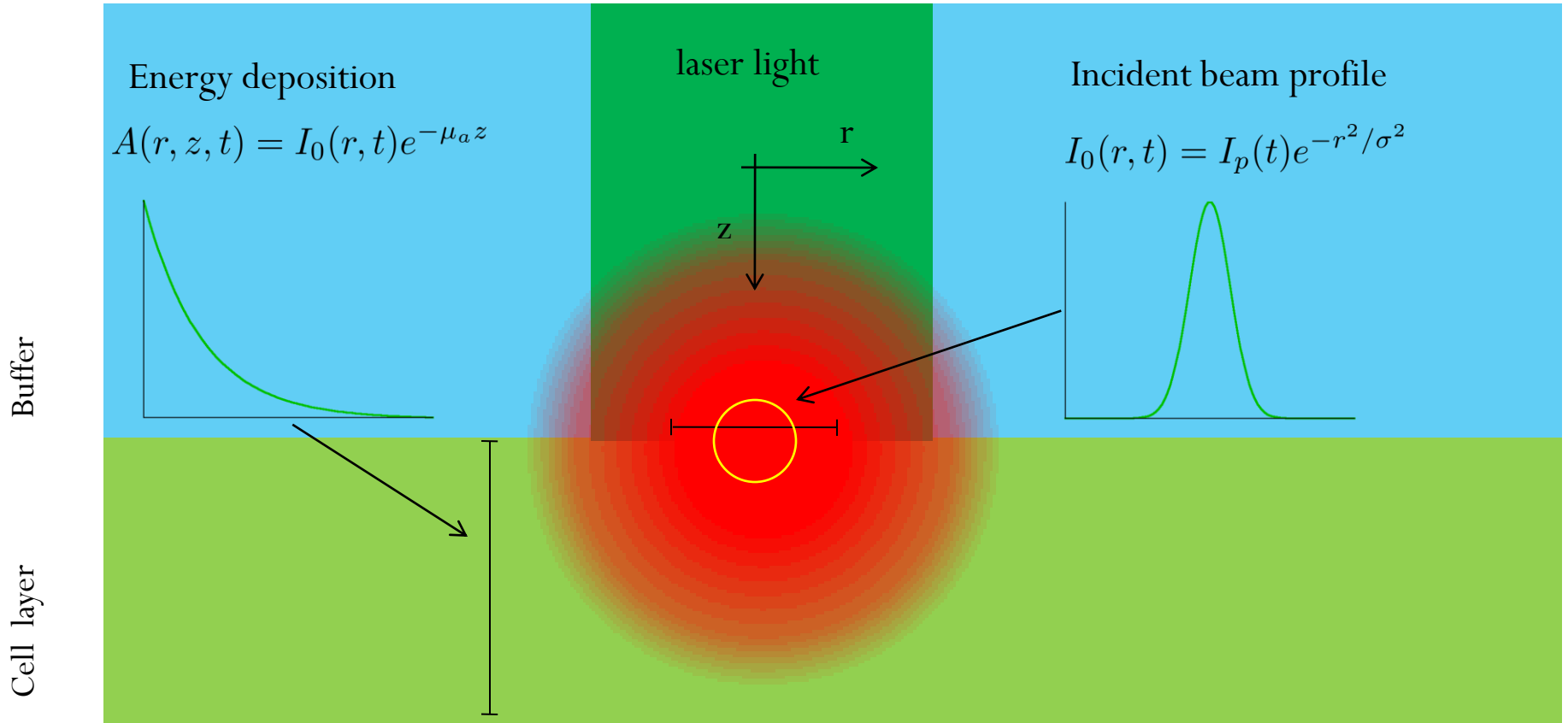
Laser interaction ←

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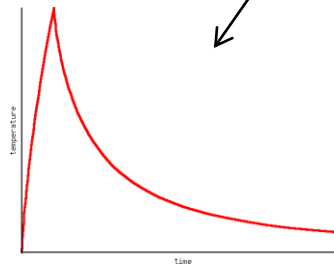
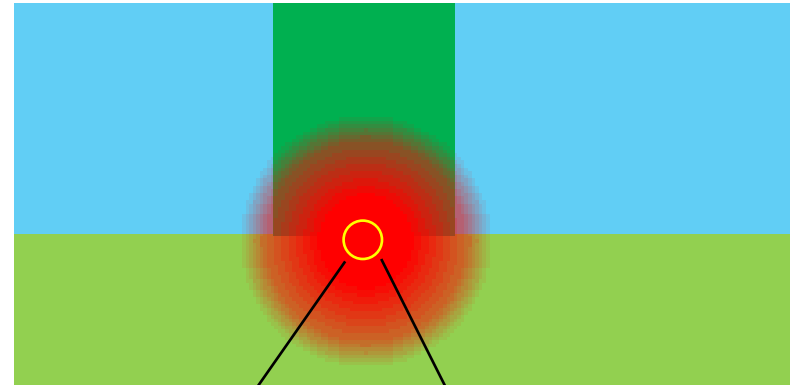
- Peak temperature rise is linearly dependent on incident laser power

$$\rho c \frac{\partial T}{\partial t} - \nabla \cdot \kappa \nabla T = I_0 e^{-\mu_a z}$$

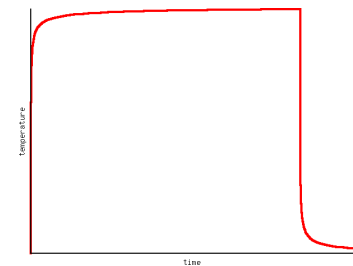


$$T = mI_0 + T_0$$

- For “long” exposures, the temperature can be considered constant



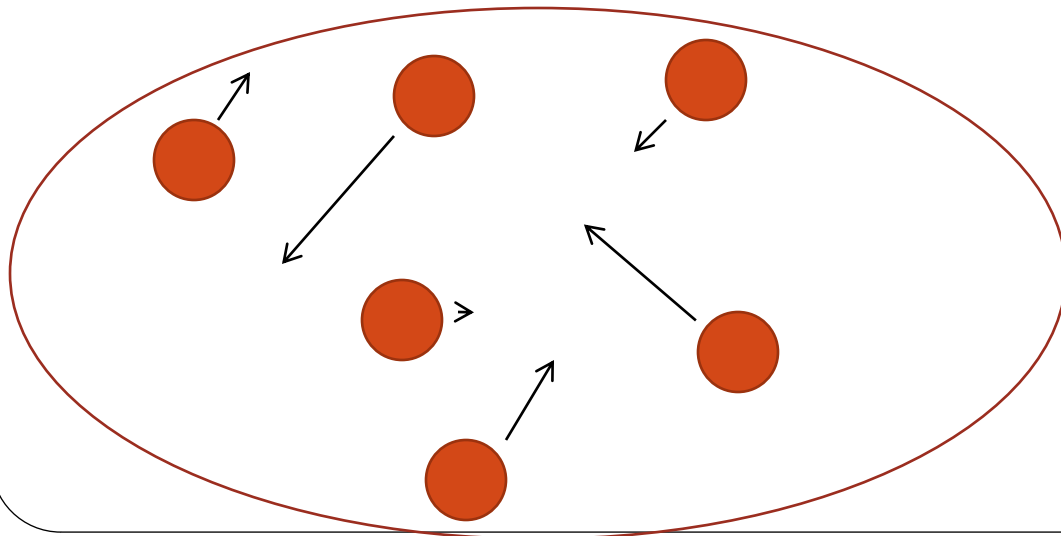
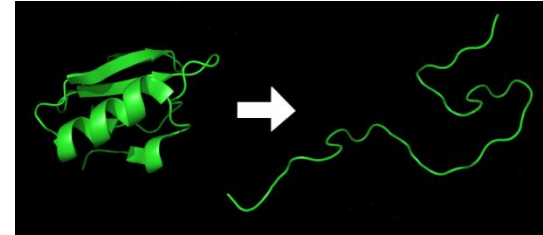
short



long

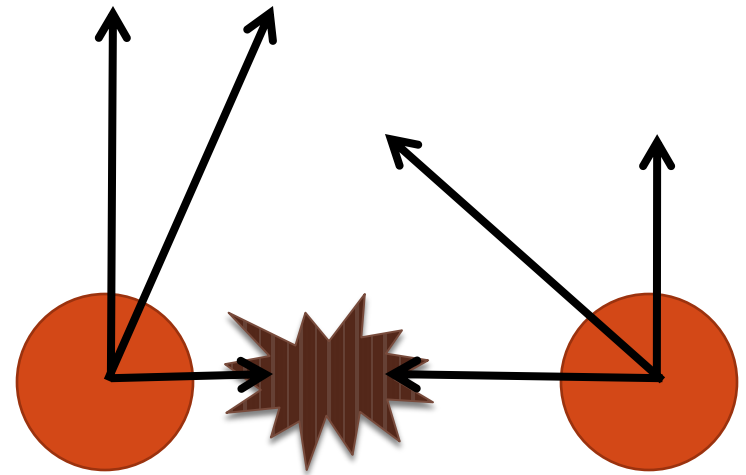
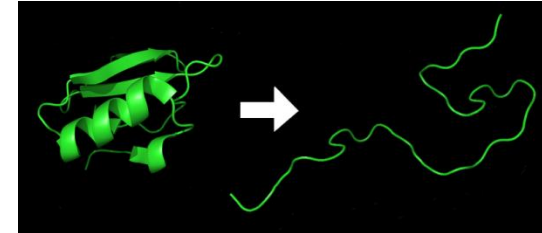
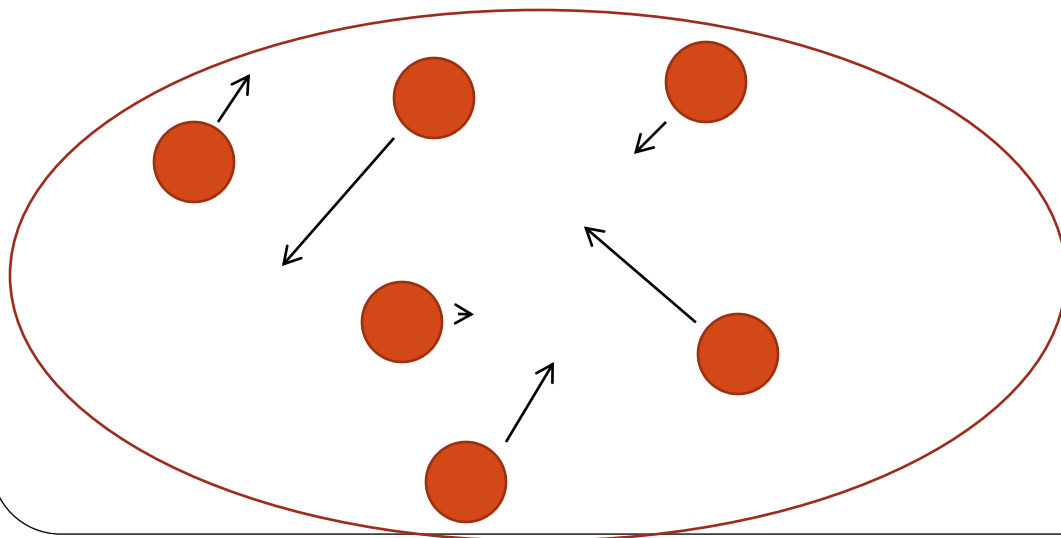
Damage Models: Thermal

- Proteins collide with each other and unfold
- Accumulation of unfolded protein is a chemical reaction
- Damage occurs if enough proteins are denatured



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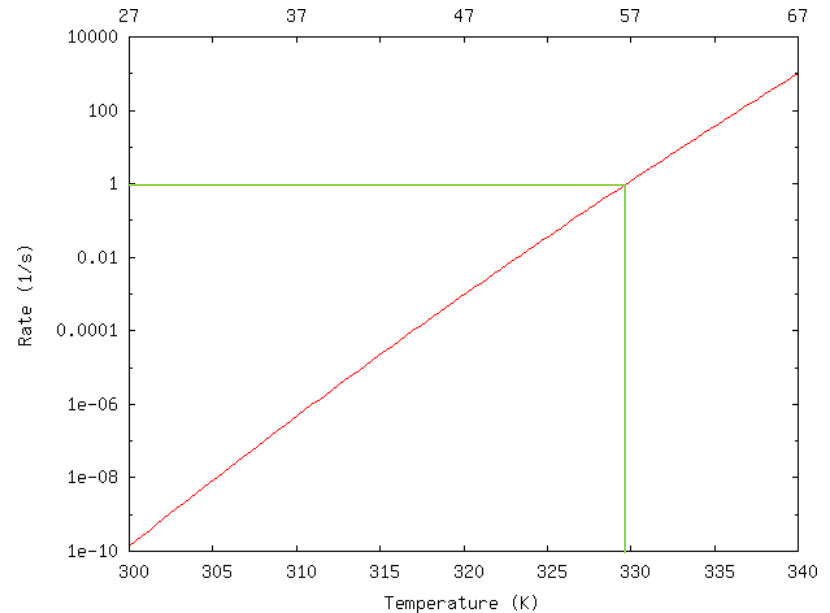
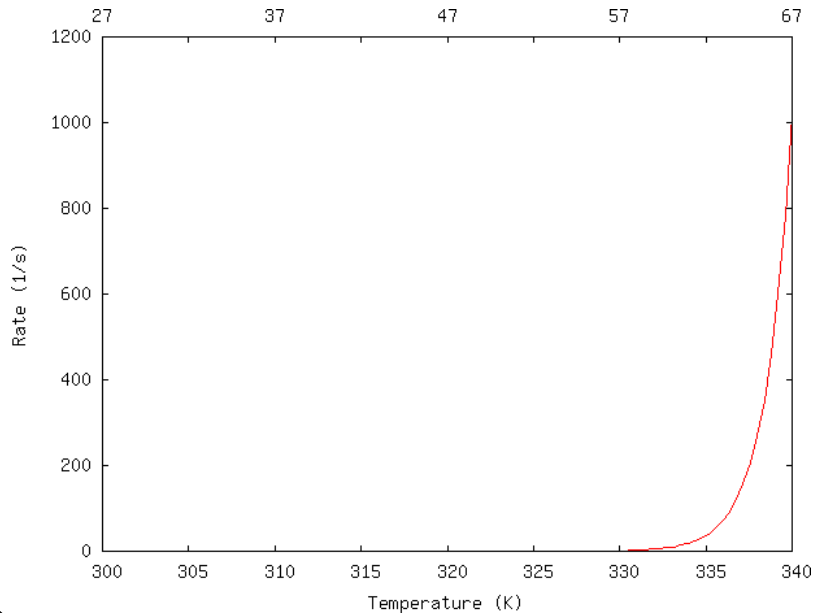
$$\frac{d\Omega}{dt} = Ae^{-\frac{E_a}{RT}}$$

Arrhenius Rate

The Famous Arrhenius Rate

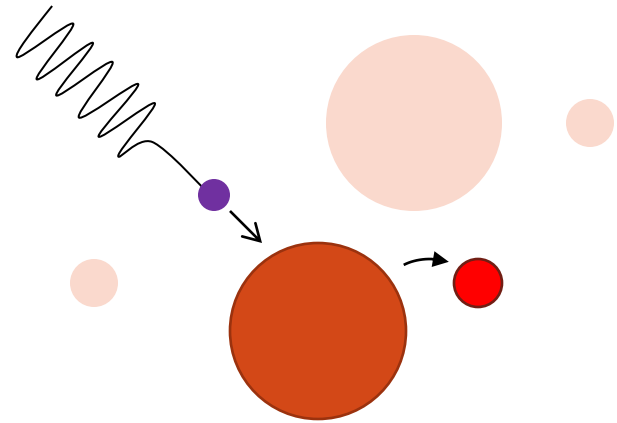
- The rate of a “zeroth-order” chemical reaction

$$\frac{d\Omega}{dt} = Ae^{-\frac{E_a}{RT}(t)}$$



Damage Models: Photochemical

- Molecule absorbs photon of (sufficient energy) and creates a free radical
- Highly reactive product goes on to disrupt cell function
- Cell death occurs if enough free radicals are produced

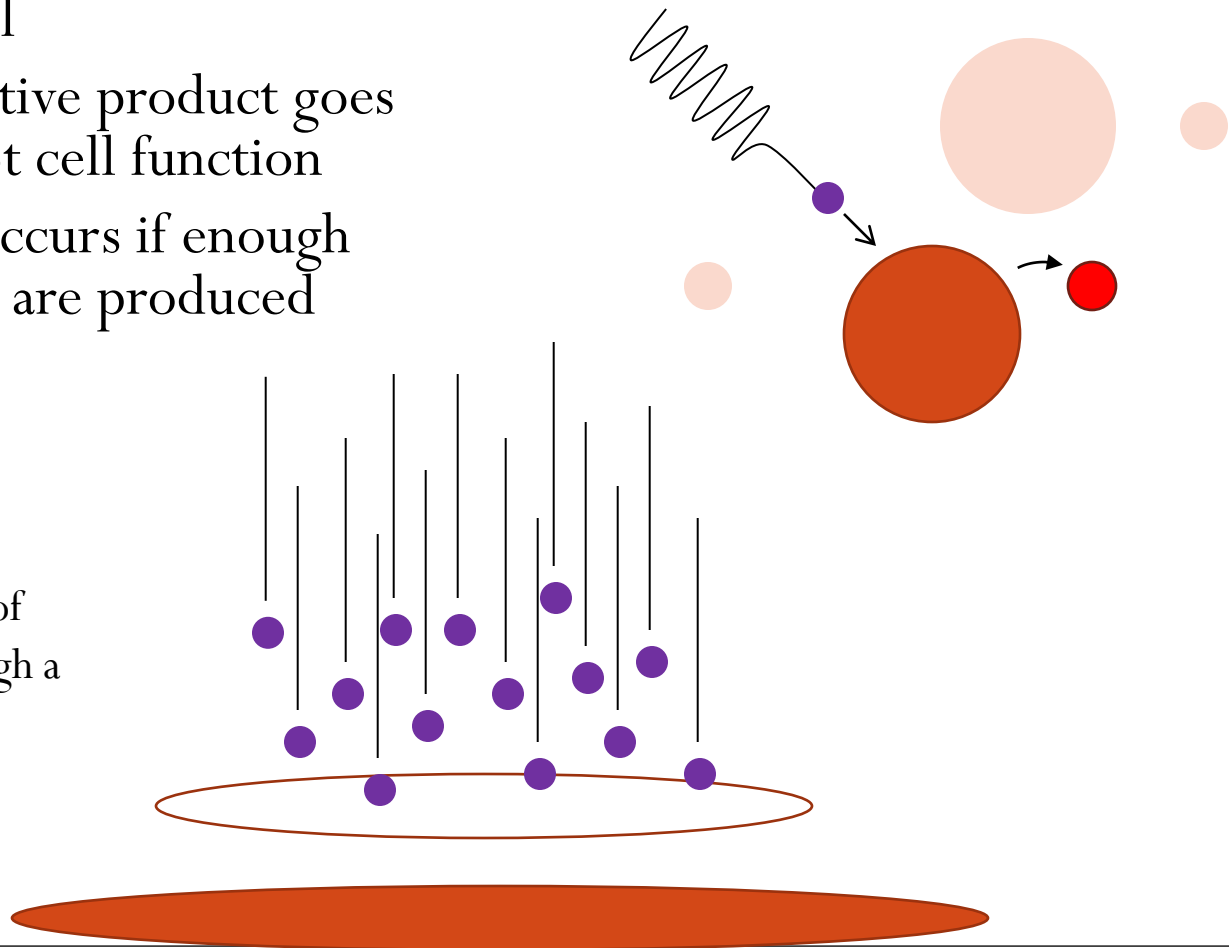


Damage Models: Photochemical

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$$\frac{d\Omega_p}{dt} = \epsilon\phi$$

Photon flux: number of photons passing through a surface, per unit type



Thermal Damage Thresholds

- Peak temperature rise is linearly dependent on incident laser power

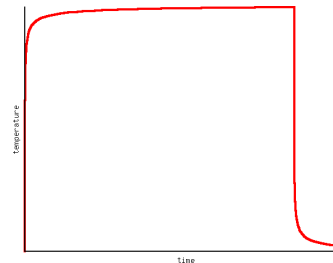
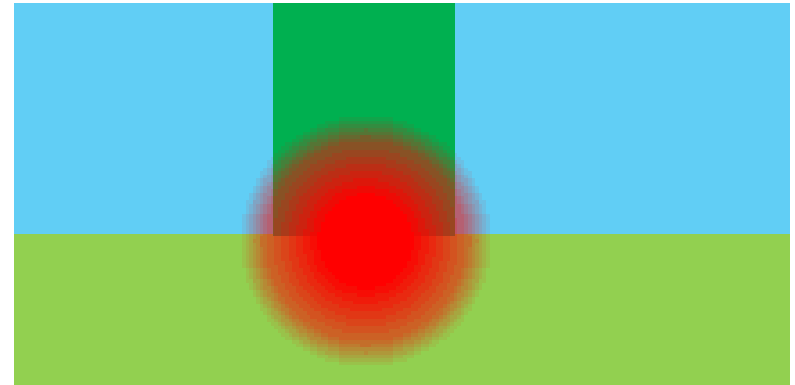
$$\rho c \frac{\partial T}{\partial t} - \nabla \cdot \kappa \nabla T = I_0 e^{-\mu_a z}$$



$$T = mI_0 + T_0$$

- For “long” exposures, the temperature can be considered constant
- Given the temperature, we can compute the accumulated damage

$$\frac{d\Omega}{dt} = A e^{-\frac{E_a}{RT}}$$
$$\Omega(\tau) = \int_0^{\tau} A e^{-\frac{E_a}{R(mI_0 + T_0)}} dt \leftarrow$$



Thermal Damage Thresholds

- We need the incident laser power as a function of damage
- Warning: possibly boring derivation to follow

Notes

$$mI_0 + T_0$$

$$\Omega(\tau) = Ae^{-\frac{E_a}{R(mI_0 + T_0)} \tau}$$

$$\Omega(\tau) = 1$$

$$1 = Ae^{-\frac{E_a}{R(mI_0 + T_0)} \tau}$$

$$0 = \ln(A\tau) - \frac{E_a}{R(mI_0 + T_0)}$$

$$(mI_0 + T_0) = \frac{E_a}{R \ln(A\tau)}$$

$$I_0 = \frac{1}{m} \left(\frac{E_a}{R \ln(A\tau)} - T_0 \right)$$

Damage Threshold is defined as $\Omega = 1$

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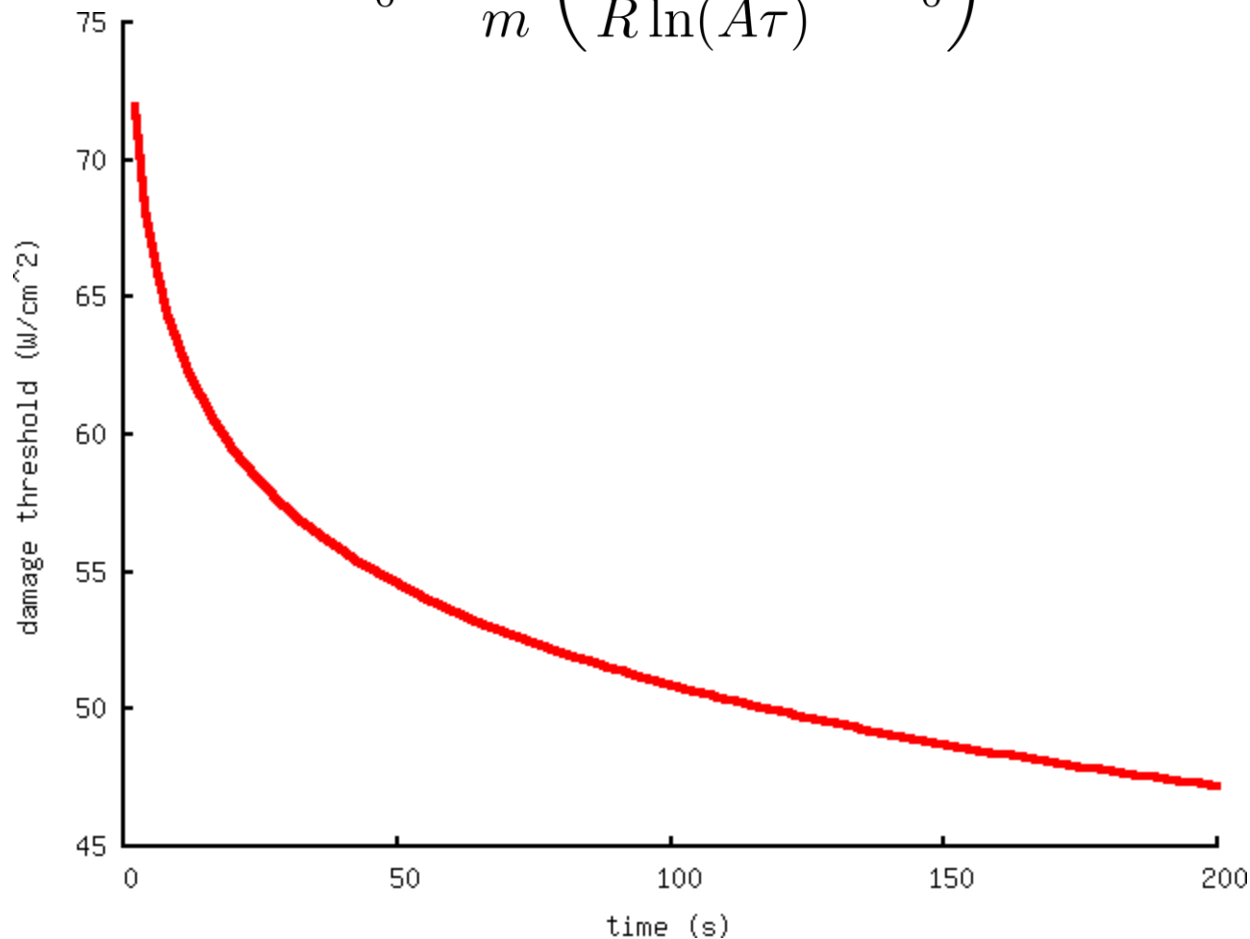
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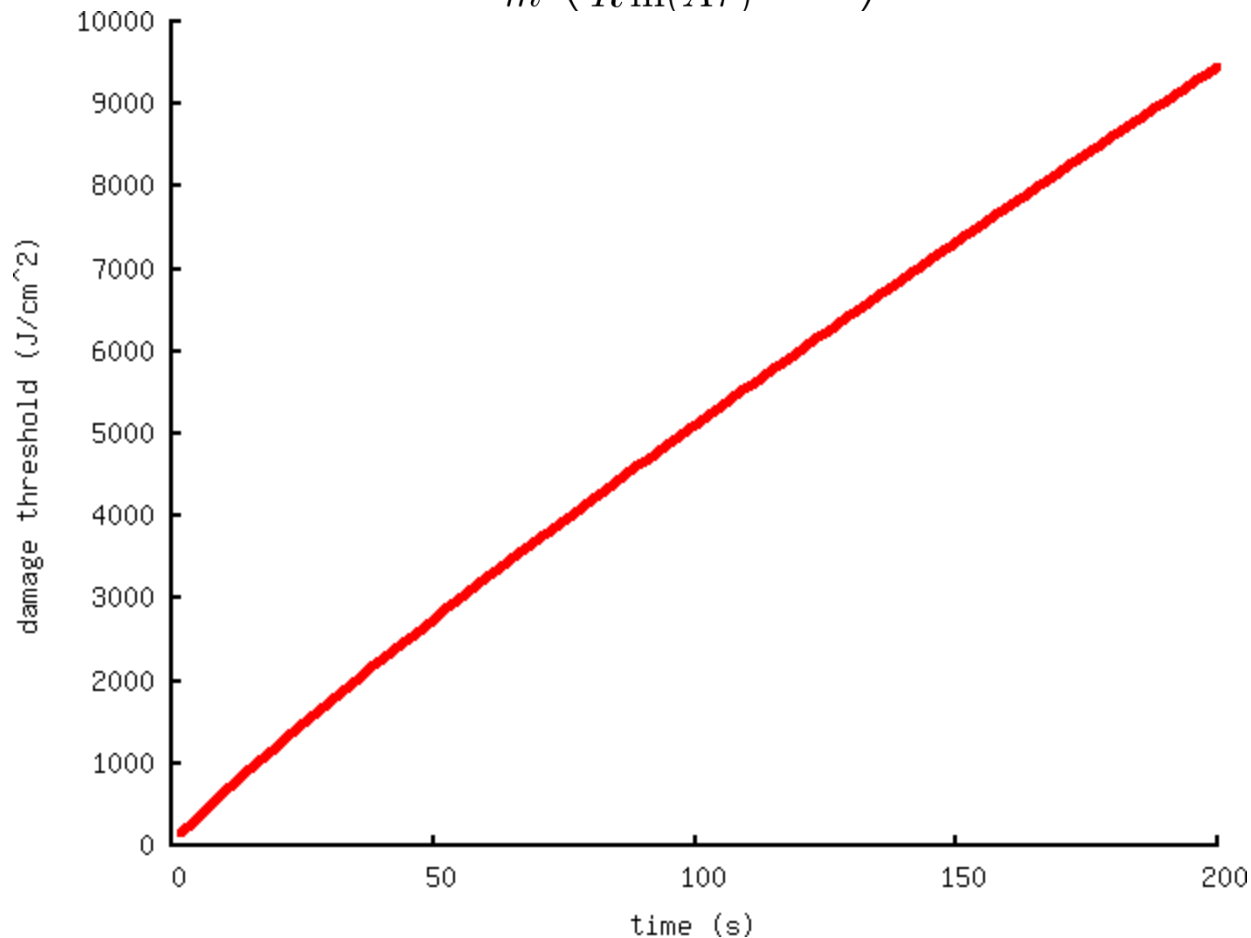
Thermal Damage Thresholds: Dependence on Exposure Duration

$$I_0 = \frac{1}{m} \left(\frac{E_a}{R \ln(A\tau)} - T_0 \right)$$

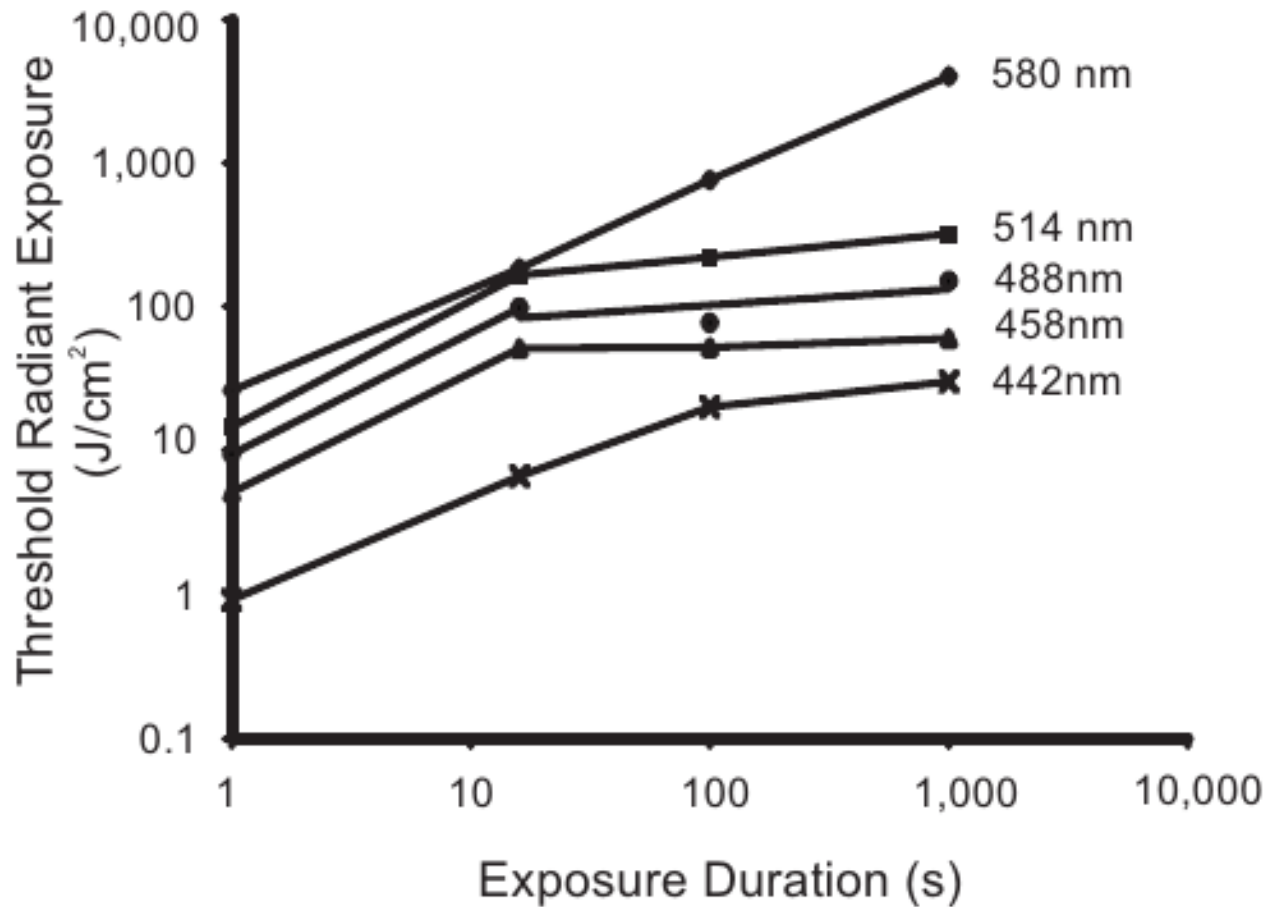


Thermal Damage Thresholds: Radiant Exposure (total number of photons)

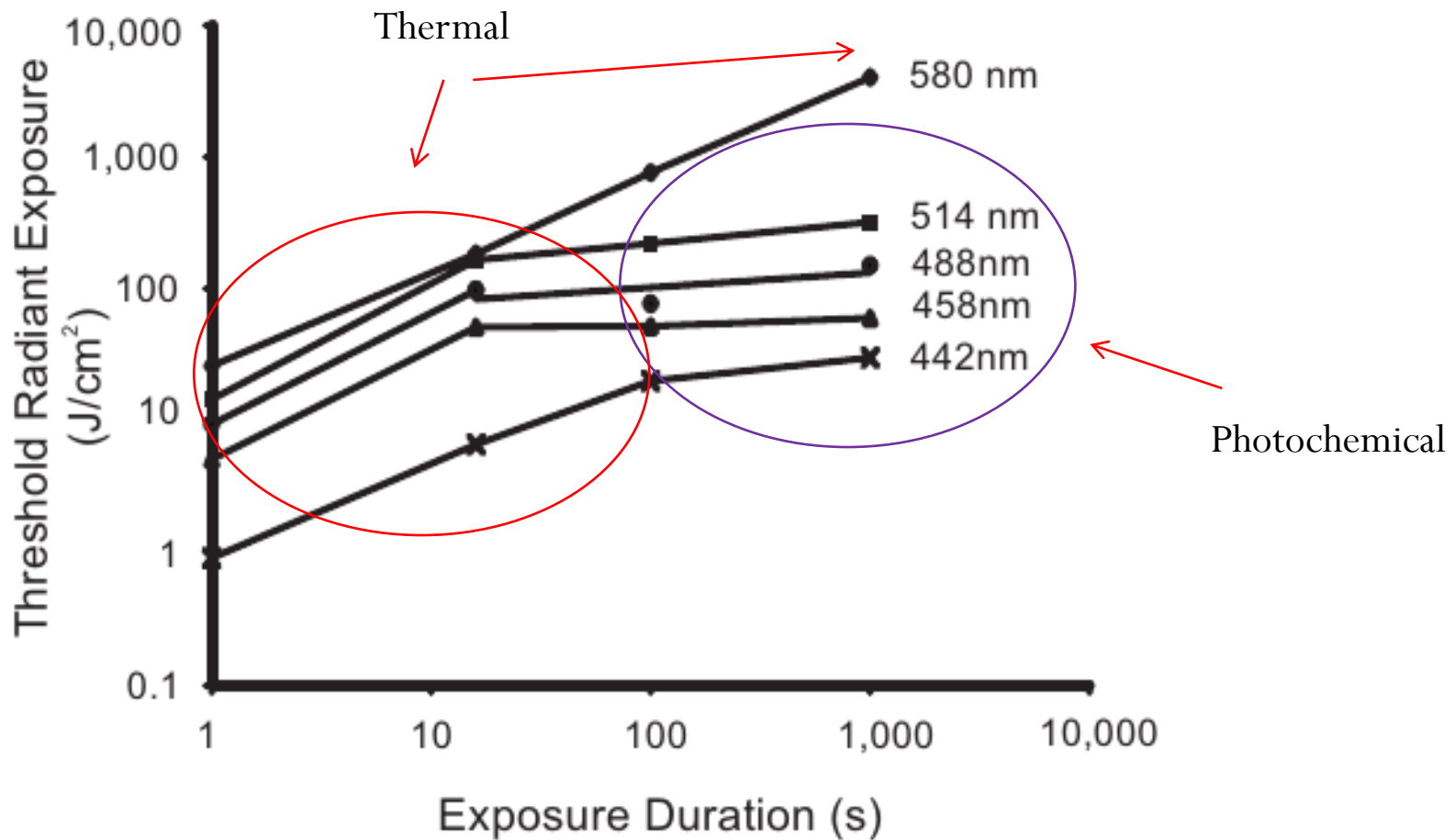
$$E_0 = I_0\tau = \frac{\tau}{m} \left(\frac{E_a}{R \ln(A\tau)} - T_0 \right)$$



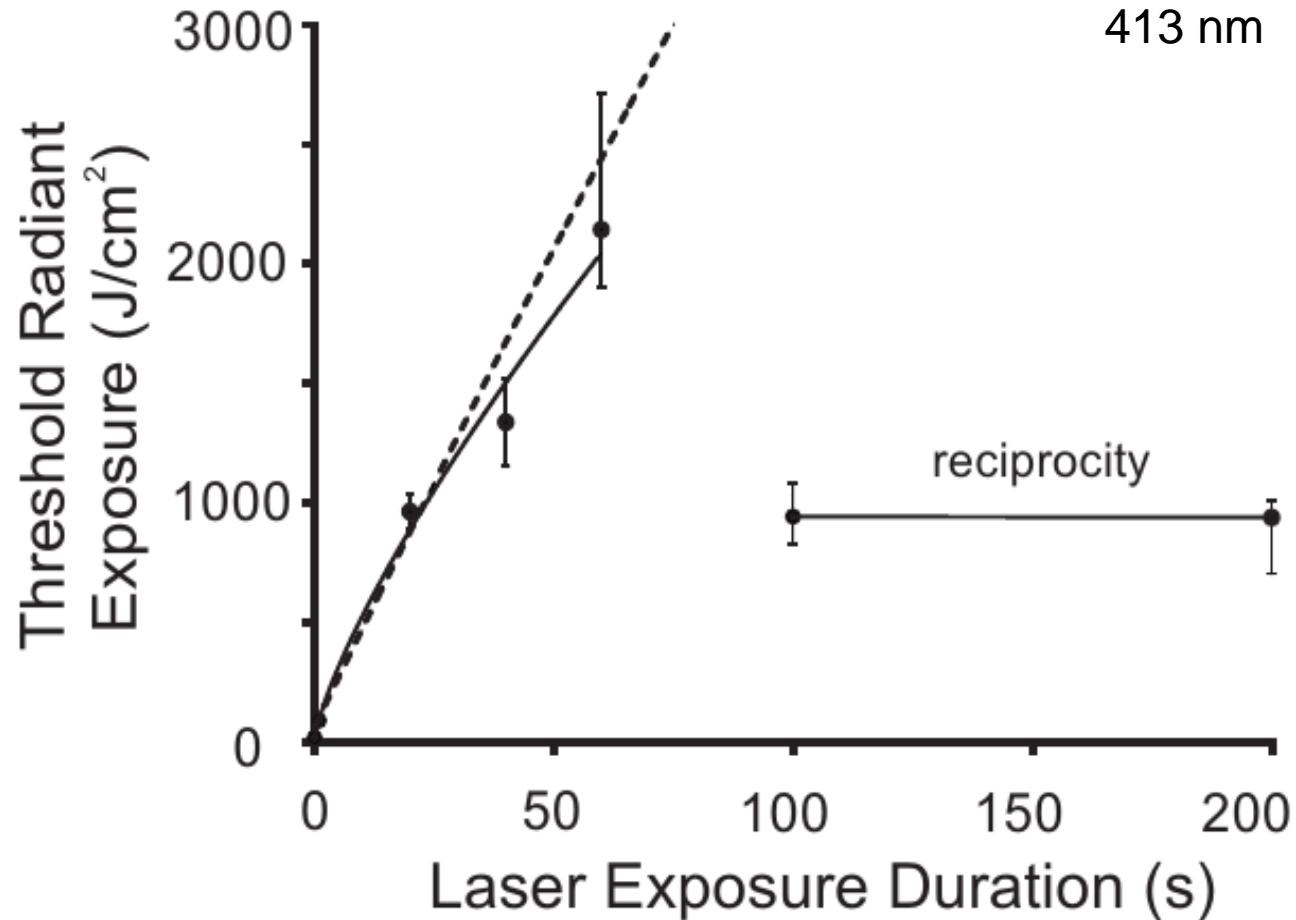
Experimental Data



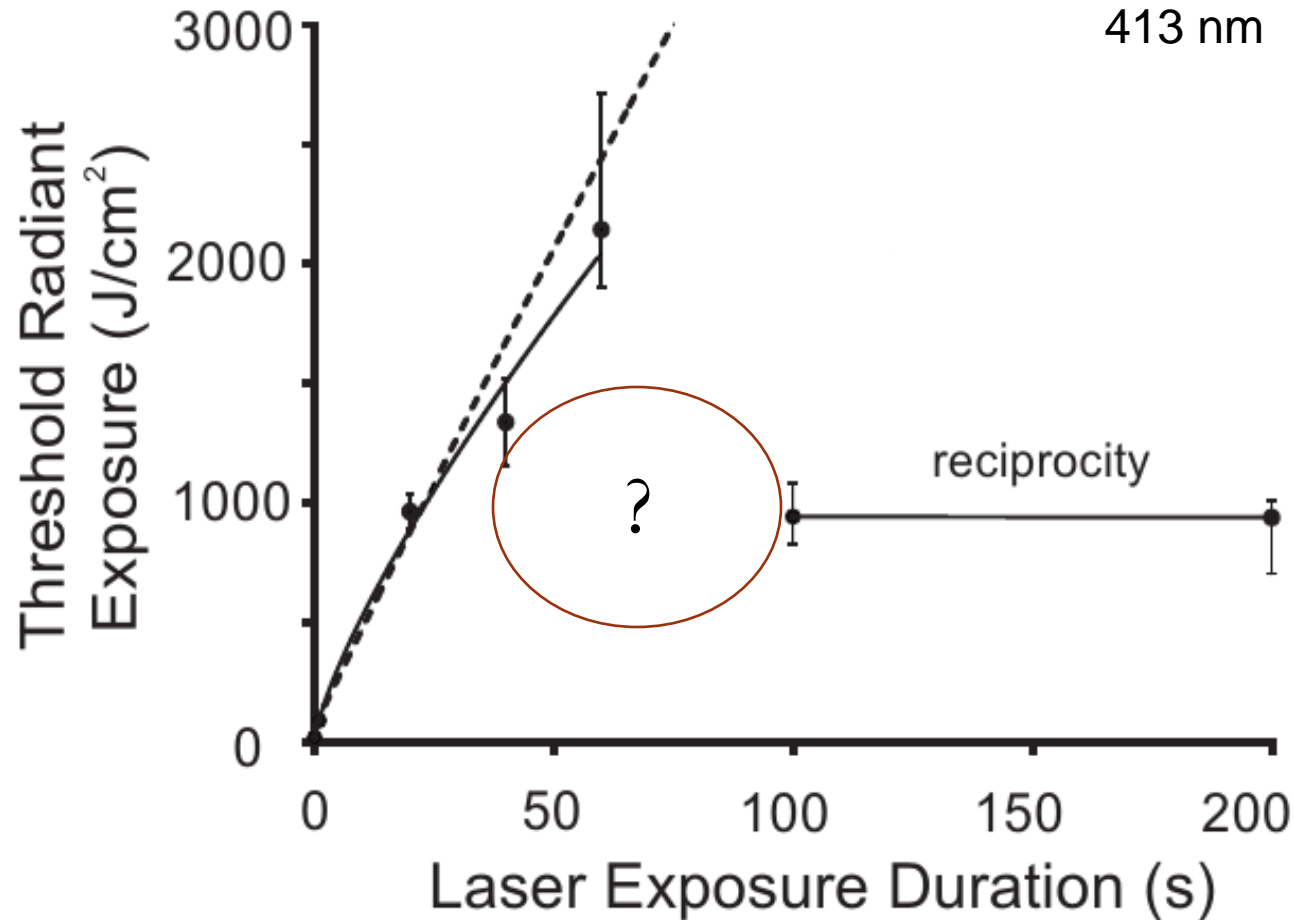
So we're done



But wait...



But wait...

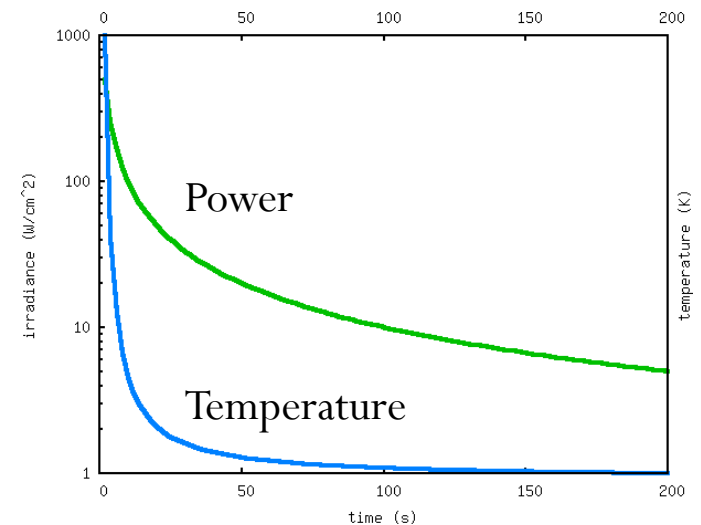
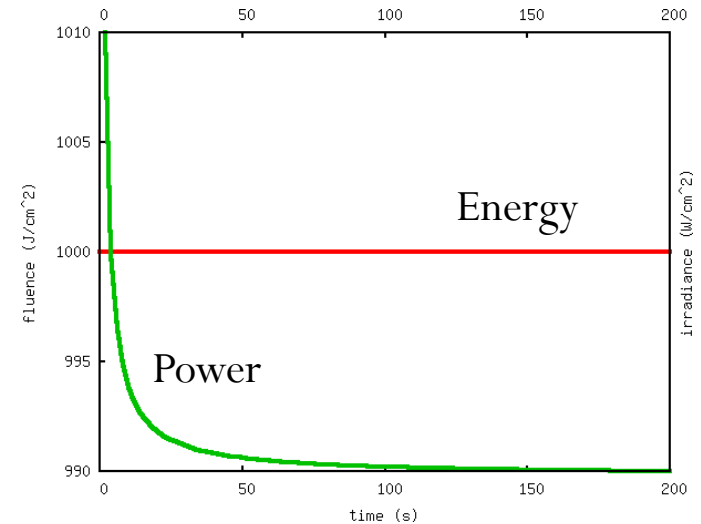


Recall

$$I_0 = \frac{E_0}{\tau}$$

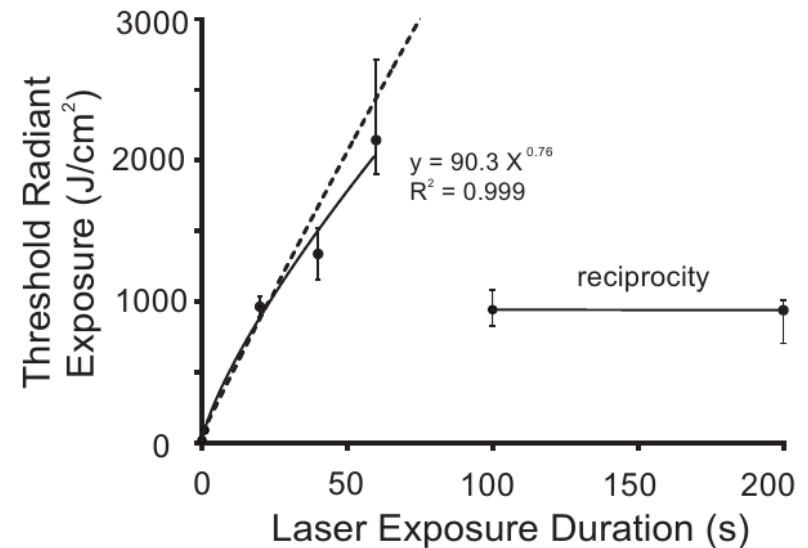
$$T = mI_0 + T_0$$

- Constant energy \rightarrow lower temperature for longer exposure
- Chemical reaction rates decrease with temperature



Our Hypothesis

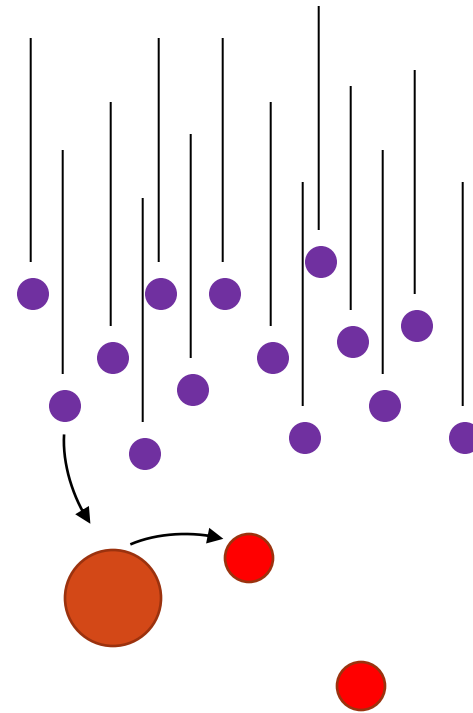
- This trend could be explained if the photochemical damage mechanism could be “shut off” for exposures less than 100 seconds
- Exposures less than 100 seconds lead to higher temperature rises
- So, if the photochemical damage mechanism could be shut off for high temperatures, we would expect this effect



A New Model

- Molecule (blue) absorbs a photon (green) and creates a toxic product (red)

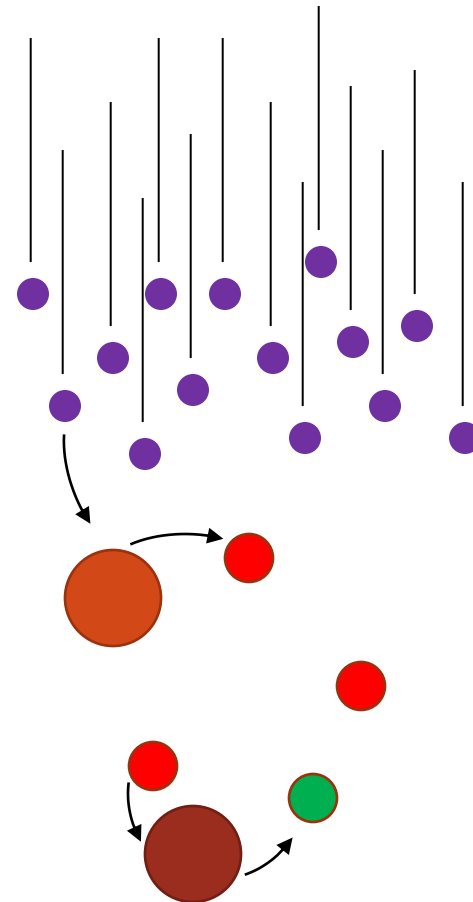
$$\frac{d\Omega_p}{dt} = \epsilon\phi$$



A New Model

- Add quenching rate
 - Toxic product reacts with some other molecule (orange) to produce a non-toxic product

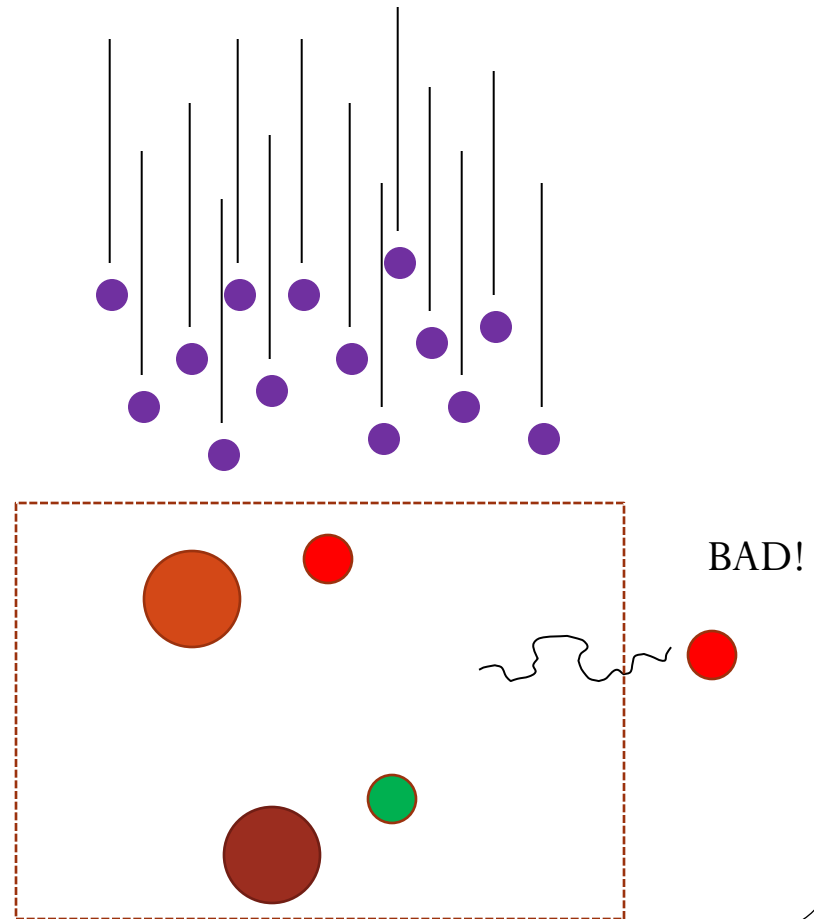
$$\frac{d\Omega_p}{dt} = \epsilon\phi - \Omega_p A_p e^{-E_{ap}/RT(t)}$$



A New Model

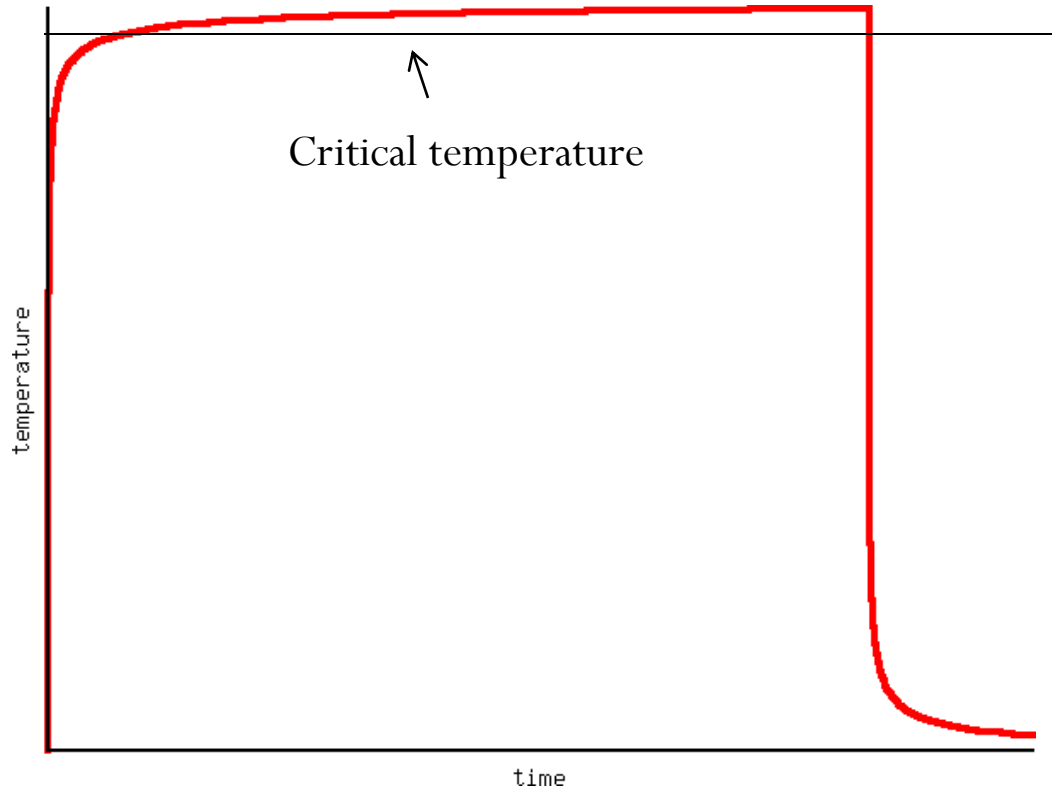
- Add quenching rate
 - Damage is caused if toxic product is allowed to migrate around the cell.
 - Threshold will correspond to some dangerous level of buildup

$$\frac{d\Omega_p}{dt} = \epsilon\phi - \Omega_p A_p e^{-E_{ap}/RT(t)}$$



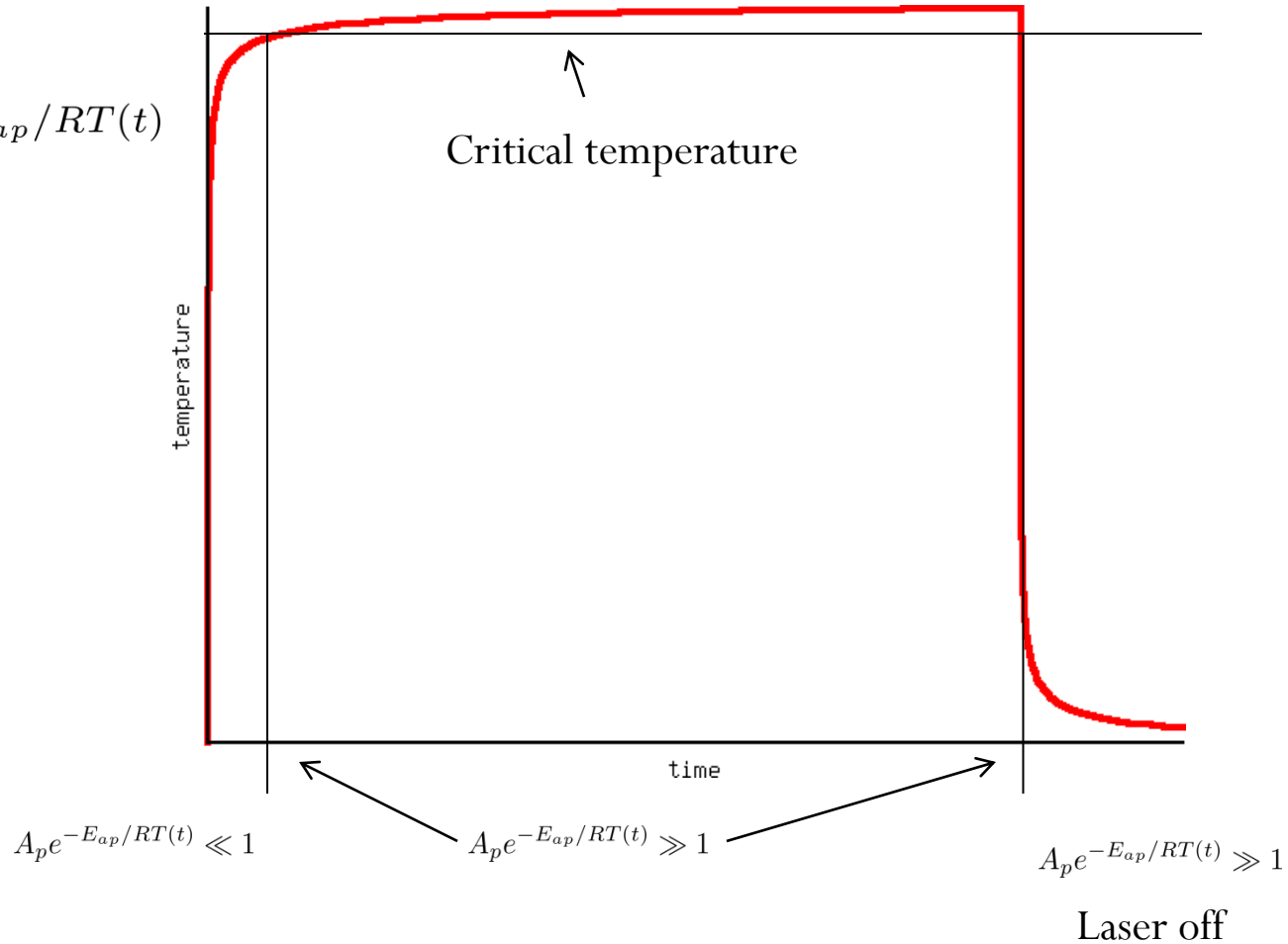
Turning off photochemical damage

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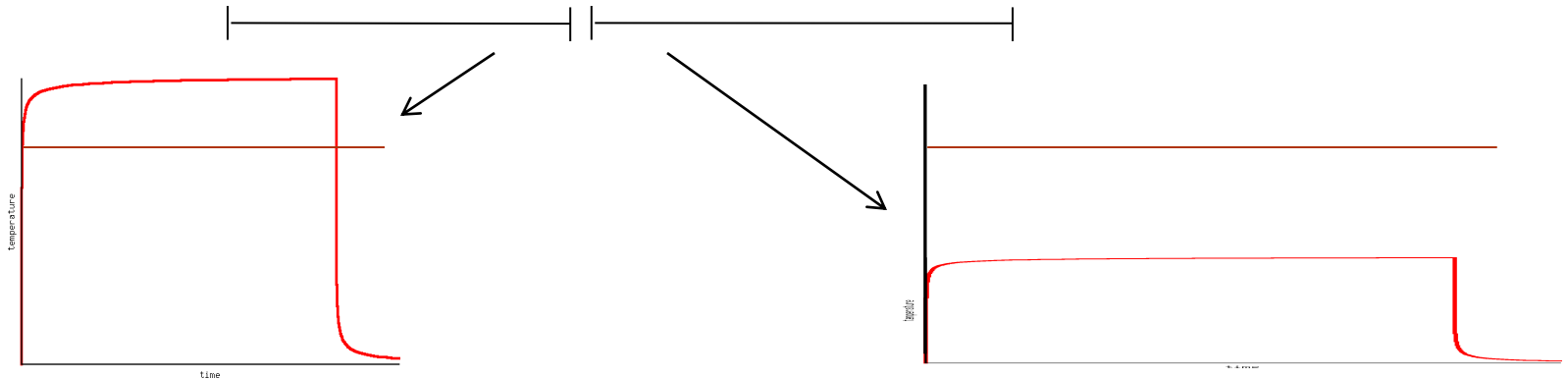
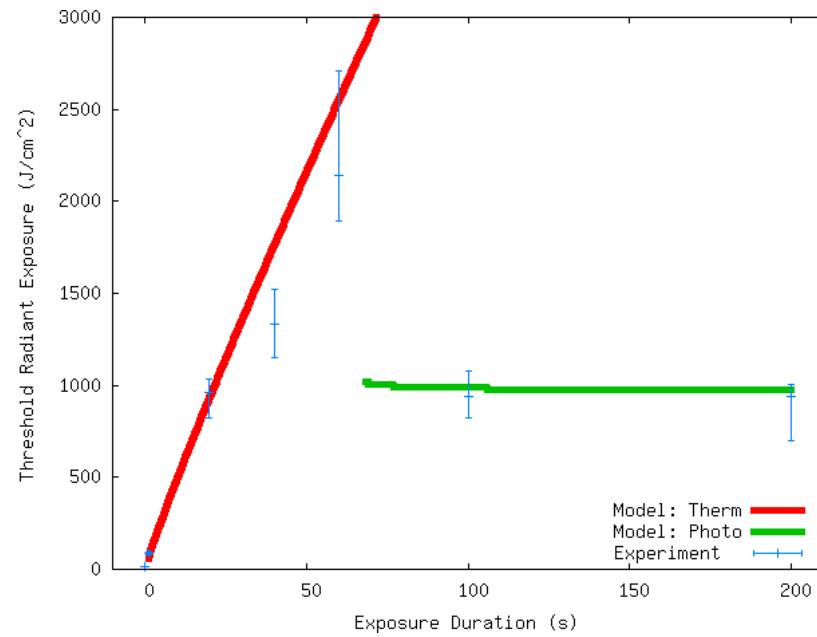


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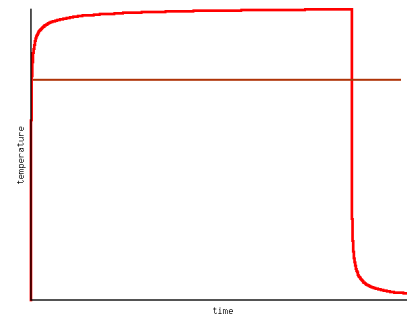
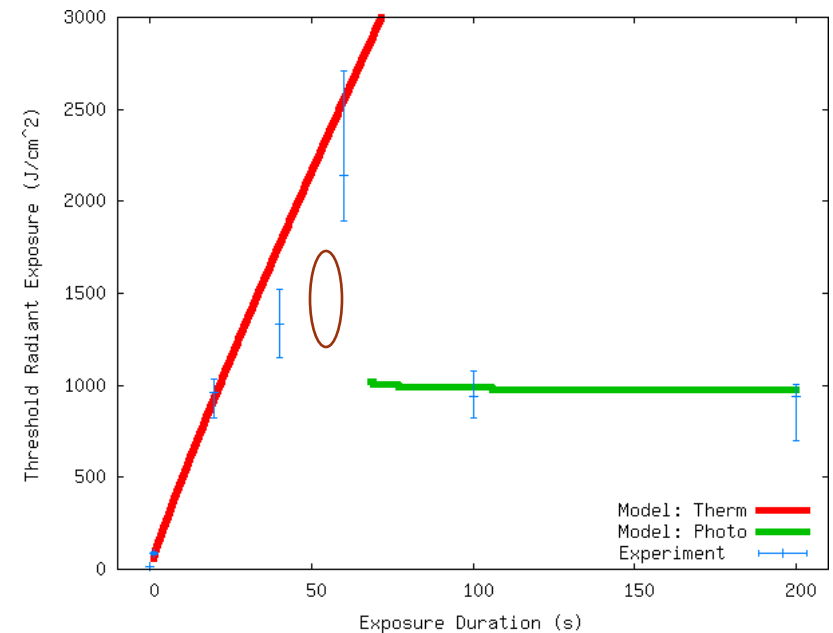


Predicted Damage Thresholds



Future Experiments

- The thermal-photochemical transition could be explained by a simple “minimum time to cause damage” model
- A multiple-pulse experiment could help validate our hypothesis.
- Photochemical damage additivity is greatly reduced under our model



Conclusions

- The disconnect between thermal damage thresholds and photochemical damage thresholds can be explained by considering a temperature dependent photochemical damage rate
- The model we have proposed requires two coefficients, which would need to be determined experimentally, just as the Arrhenius thermal damage model does
- We have neglected the details of the “efficiency” for creating photochemical damage. In reality, this will likely depend on the wavelength and possibly the temperature as well

Acknowledgements

- Air Force Research Lab – Optical Radiation Branch
 - Dr. Robert Thomas
 - Dr. Michael Denton
 - Mr. Larry Estlack
 - Dr. Ben Rockwell

Questions